

Confirmation of the spectral excess in DAMIC at SNOLAB with Skipper CCDs

*Deep Underground Physics (DUPhy) Group Meeting,
Centre Paul Langevin, CAES, CNRS*

*Michelangelo Traina, on behalf of the DAMIC(-M) collaborations
CENPA, University of Washington, Seattle (US)*

Outline:

1. DAMIC at SNOLAB
2. Background model
3. Near-threshold excess
4. SNOLAB skipper upgrade
5. Science data and selections
6. Search results





DAMIC AT SNOLAB

DARk Matter In CCDs collaboration (since 2011)

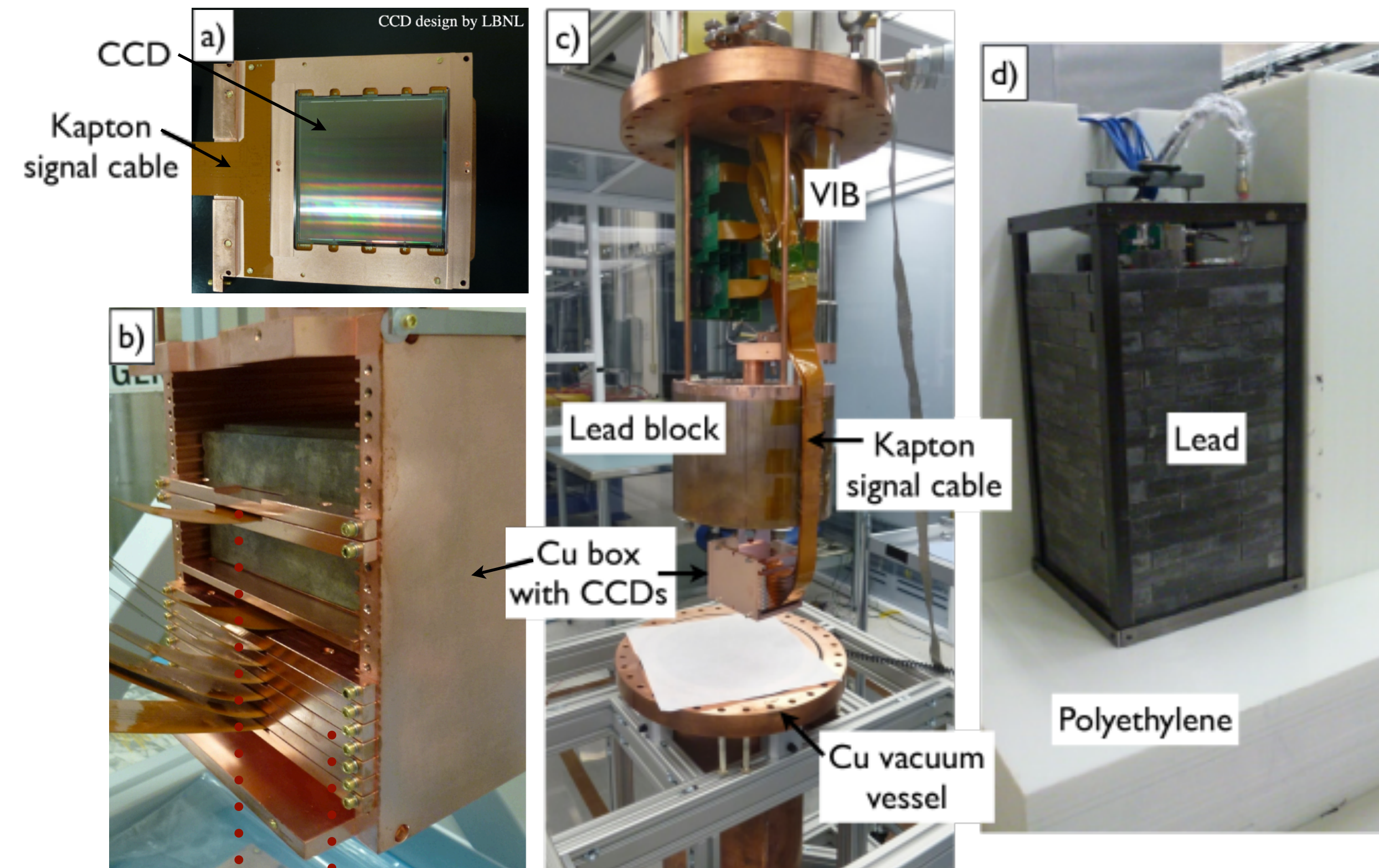
- Setup beneath 2 km of granite at **SNOLAB** (Canada)
- Sensors in cryogenic conditions (10^{-6} mbar, 140 K)

Charge-Coupled Devices

- Very low noise and leakage current: sensitive to e^-
- 3D track reconstruction and PID capabilities

For Dark Matter:

- Several thick CCDs \Rightarrow massive target
 $7 \times 675 \mu\text{m}$ $\sim 40 \text{ g}$
- Sensitive to:
 - WIMP-nucleus coherent scattering
 - Hidden sector light DM- e^- interactions

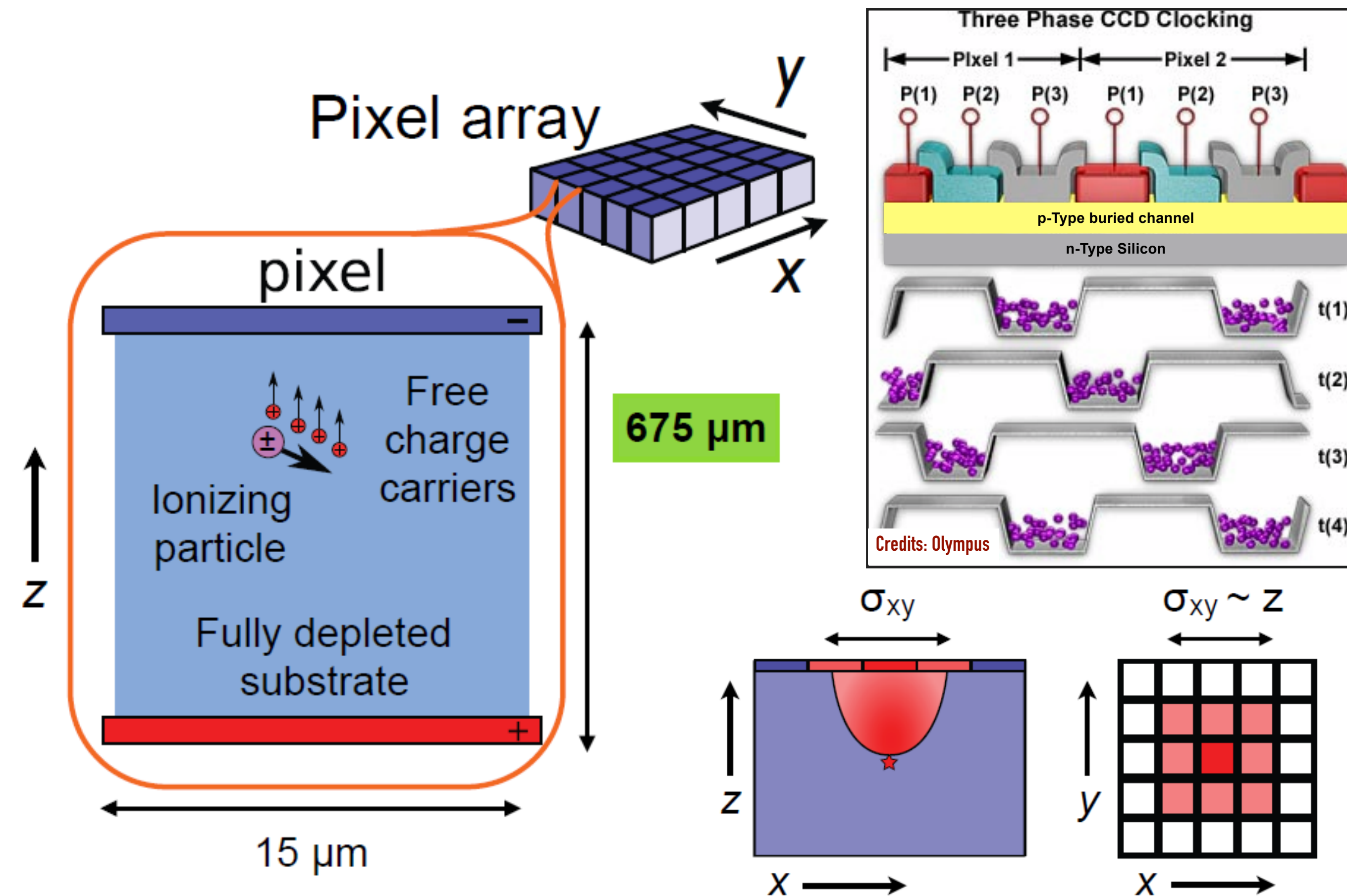


CCD 1
CCDs 2-7

- a) Packaged DAMIC CCD
- b) Copper CCD housing
- c) In-vacuum setup
- d) Pb and polyethylene outer shielding



CHARGE-COUPLED DEVICES



DAMIC science-grade CCDs

- PolySi gate, p-type buried channel structure
- Fully depleted at 40 V ($\sim 10 \text{ k}\Omega \cdot \text{cm}$)

Performance

- Charge transfer inefficiency $< 10^{-6}$
- Readout noise $< 2 e^-$ (6 eV)
- Leakage current $\sim 10^{-4} e^-/\text{pix}/\text{day}$

Sample CCD image (~15 min exposure) portion in the surface lab.

~1 cm

Cosmic muon →

Diffusion-limited ↓

β particle ↑

$\sigma_{back} > \sigma_{front}$

Image courtesy of Prof. A. Chavarria



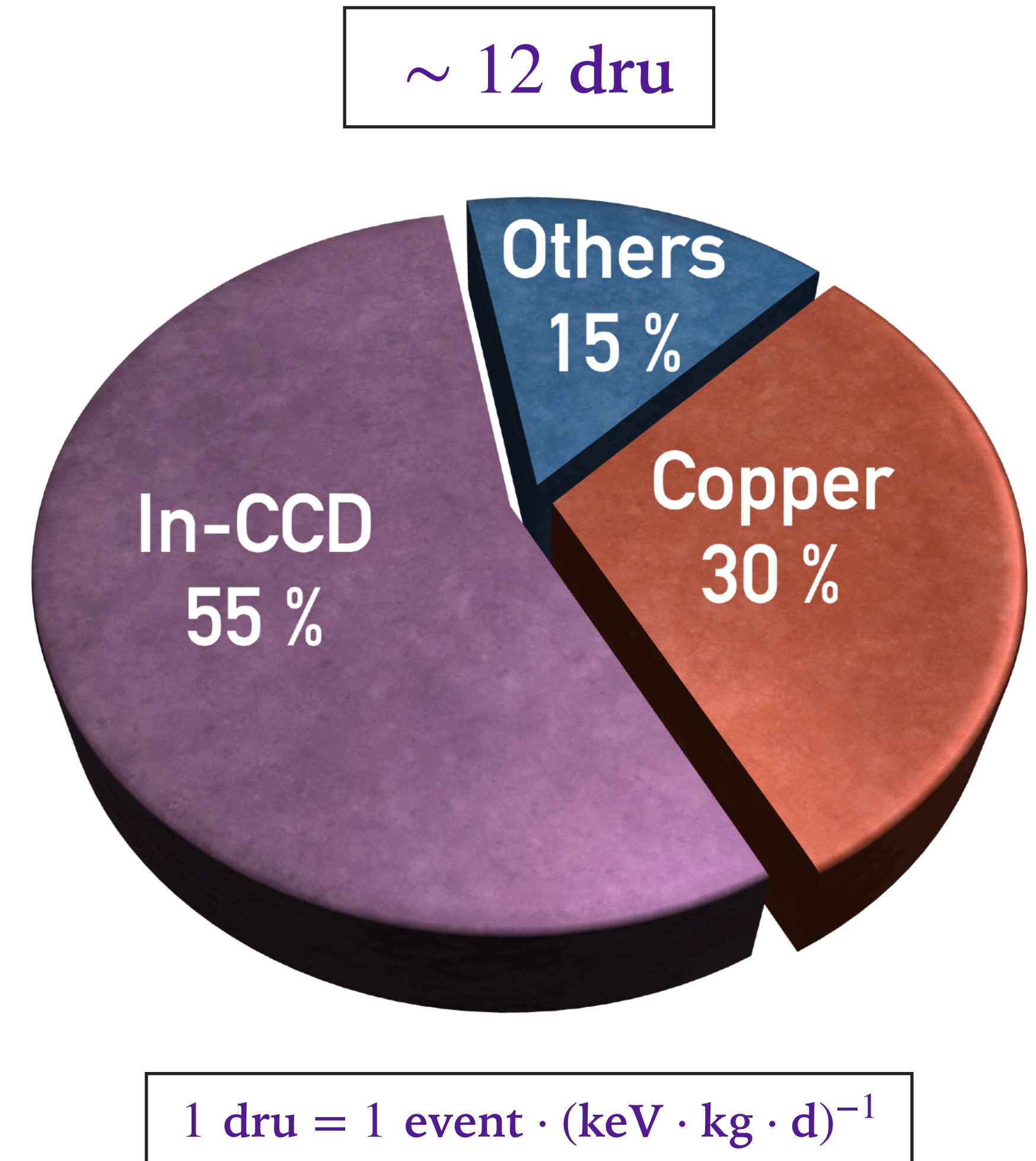
BACKGROUNDS IN DAMIC

How we deal with backgrounds:

- Underground operation: ~~cosmic radiation~~
- Material selection (assays): ~~apparatus radioactivity~~
- In situ shielding: ~~environmental radioactivity~~
- Discrimination and quantification of residual contaminants \Rightarrow radioactive background model

Background contributions:

- $\sim 55\%$ in-CCD contaminants
- $\sim 30\%$ OFHC copper
- $\sim 15\%$ from various detector materials (lead, flex cables, etc.)





BACKGROUND MODELING

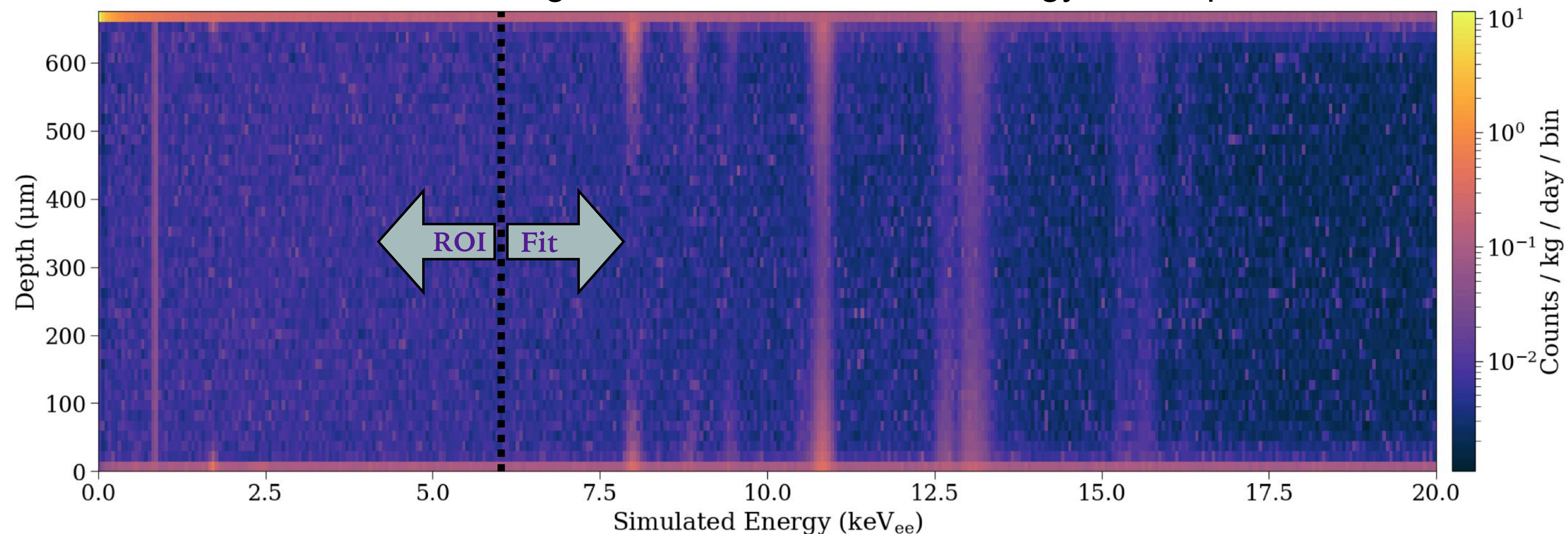
Background model construction:

Phys. Rev. D 105, 062003

- Decay and tracking across detector geometry with GEANT4
- CCD response simulation
- Reconstruction to (E, σ) analysis space
- Likelihood fit to data in WIMP-free region ($6 - 20 \text{ keV}_{ee}$) \Rightarrow extrapolate in ROI ($0.05 - 6 \text{ keV}_{ee}$)

eV_{ee} : electron-equivalent energies

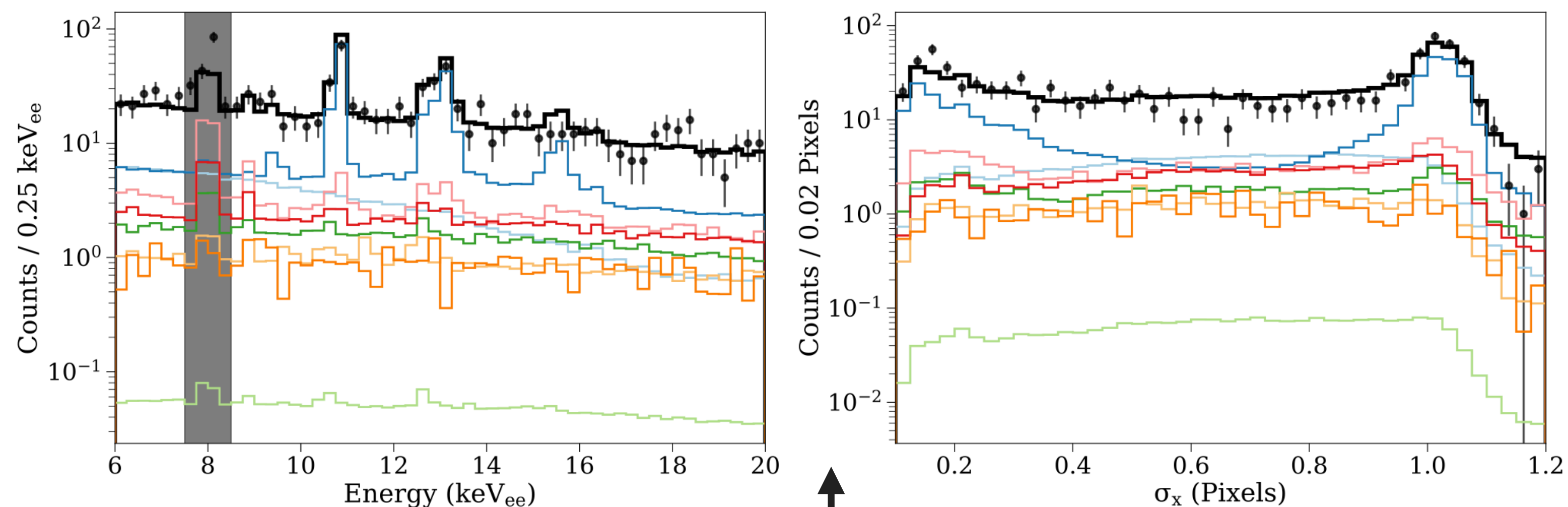
Simulated backgrounds for CCDs 2-7 in energy and depth



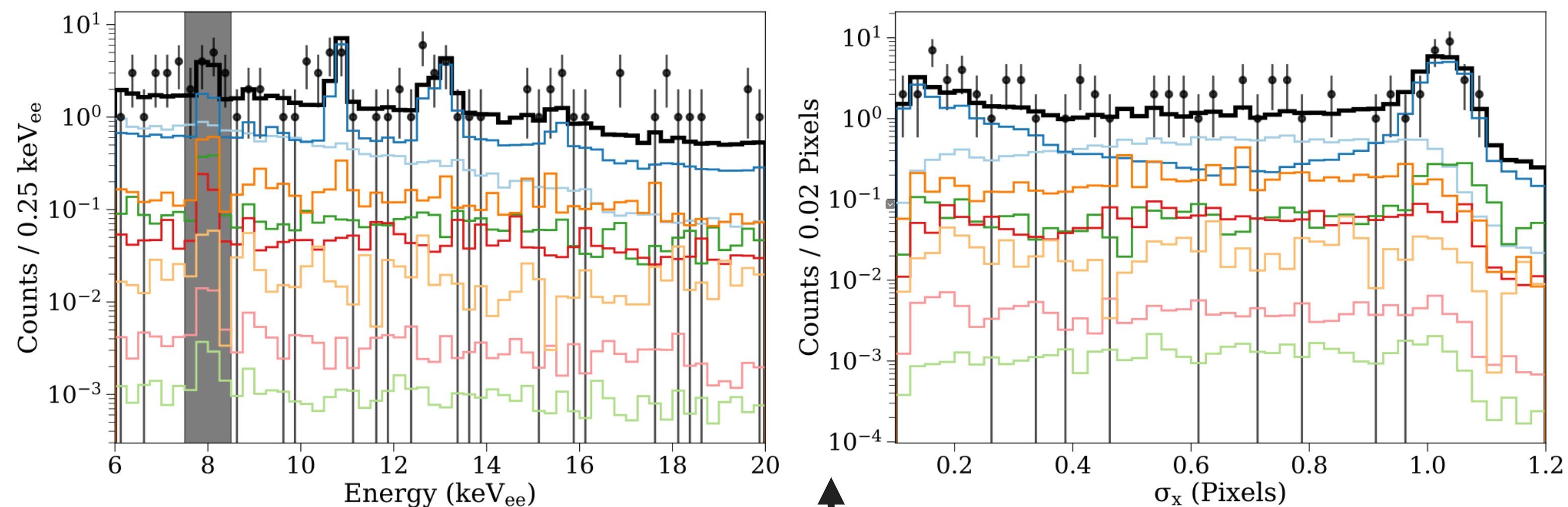


BACKGROUND TEMPLATE FITTING

- Background Model
- CCD Surface
- Kapton Cable
- Copper Box
- Ancient Lead
- CCD
- Module Screws
- Copper Modules
- Copper Vessel
- Data



Fit on CCD 2-7 data



Validation with CCD 1 data



BACKGROUND TEMPLATE FITTING

Construction of Background Templates

- Group simulations up in templates according to material and decay
- Construct number of expected events per bin, ν_{ij} :

$$\nu_{ijl} = \sum_{m=0}^{N_{det.part}} n_{ijm} \times \frac{A_l M_m(\epsilon_{data} t_{run})}{(\epsilon_{sim} N_m)}, \quad \nu_{ij} = \sum_{l=0}^{N_{templates}} C_l \nu_{ijl}$$

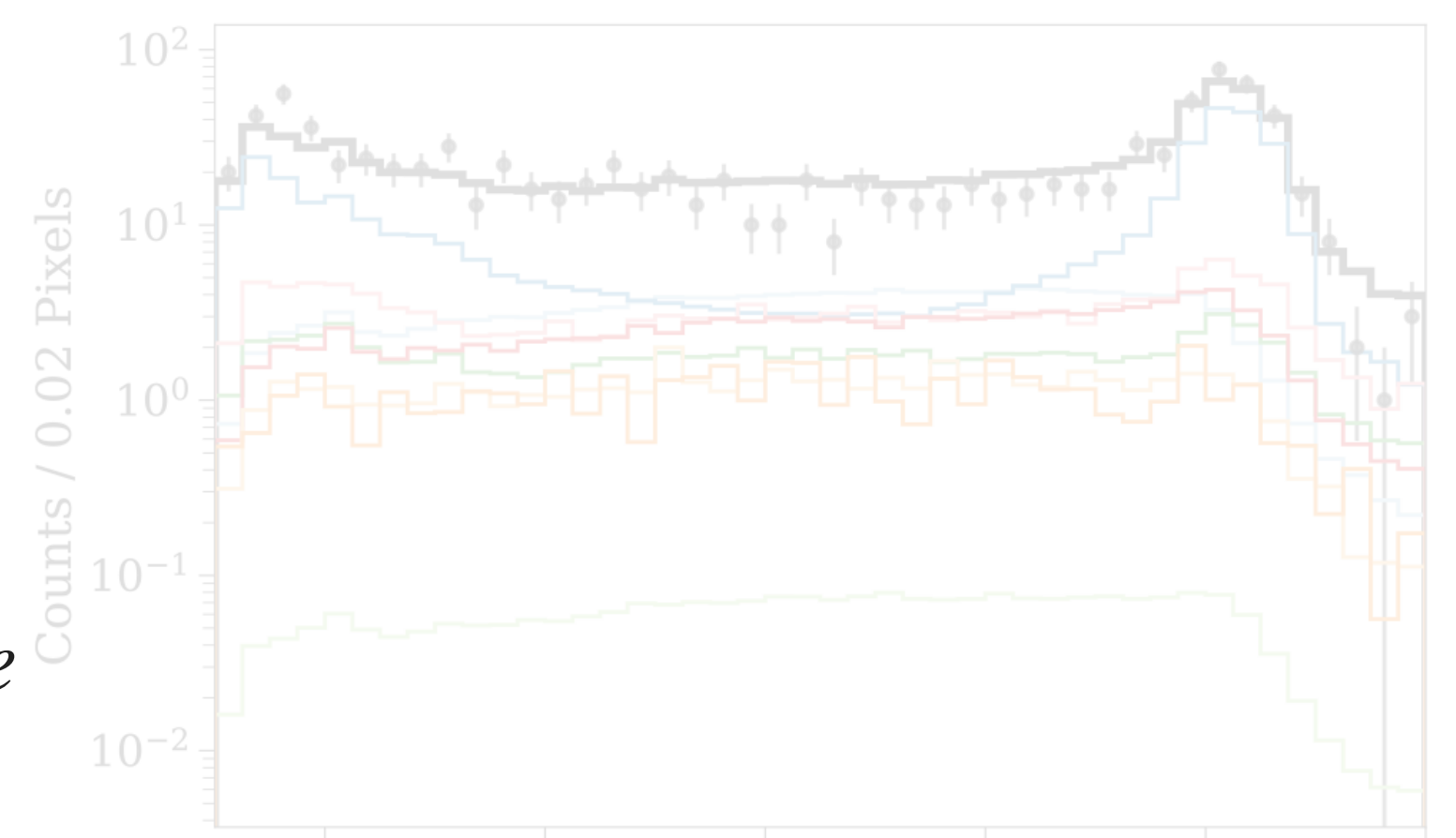
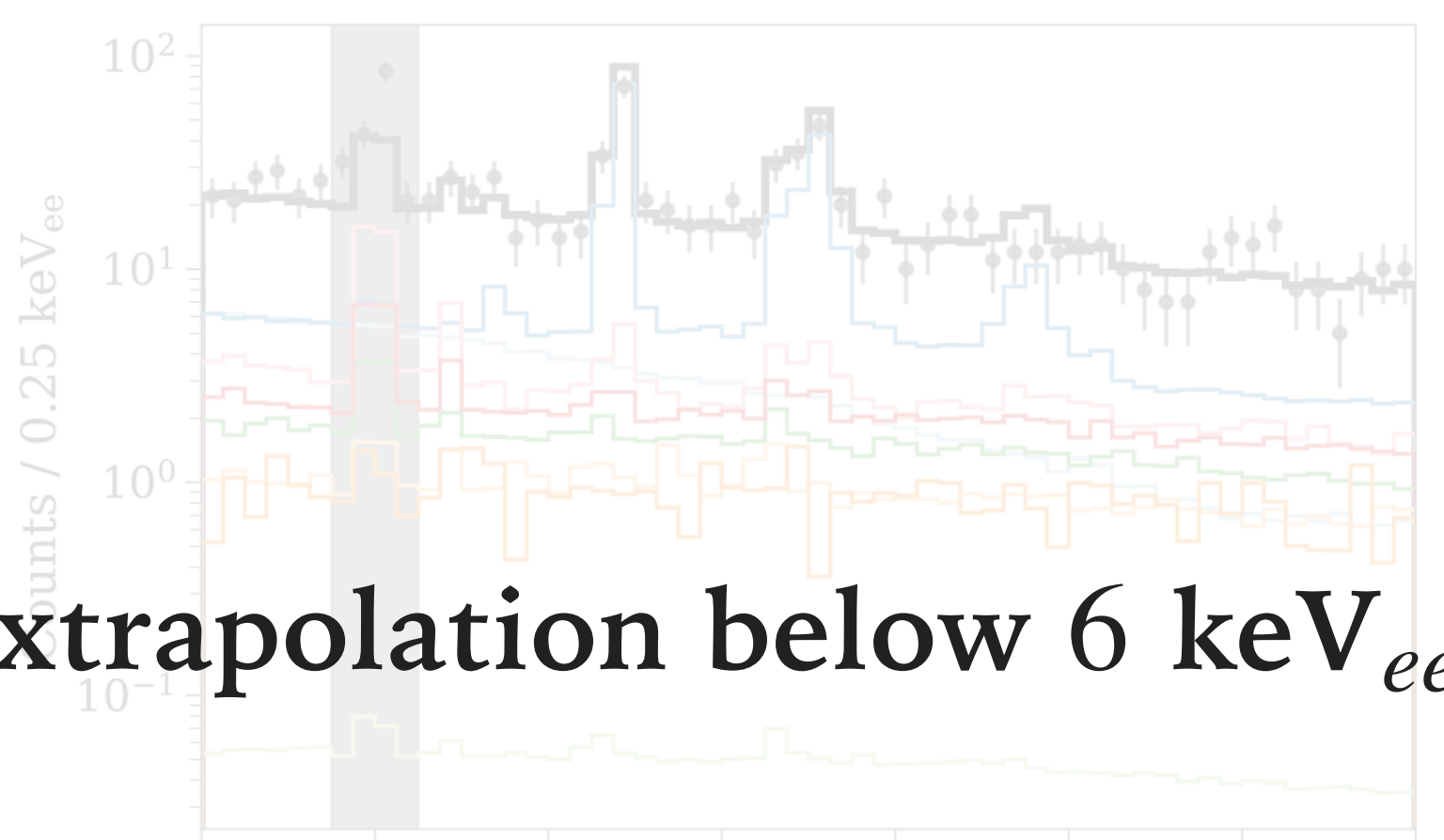
Extrapolation below 6 keV_{ee}

Analysis threshold set to 50 eV_{ee}

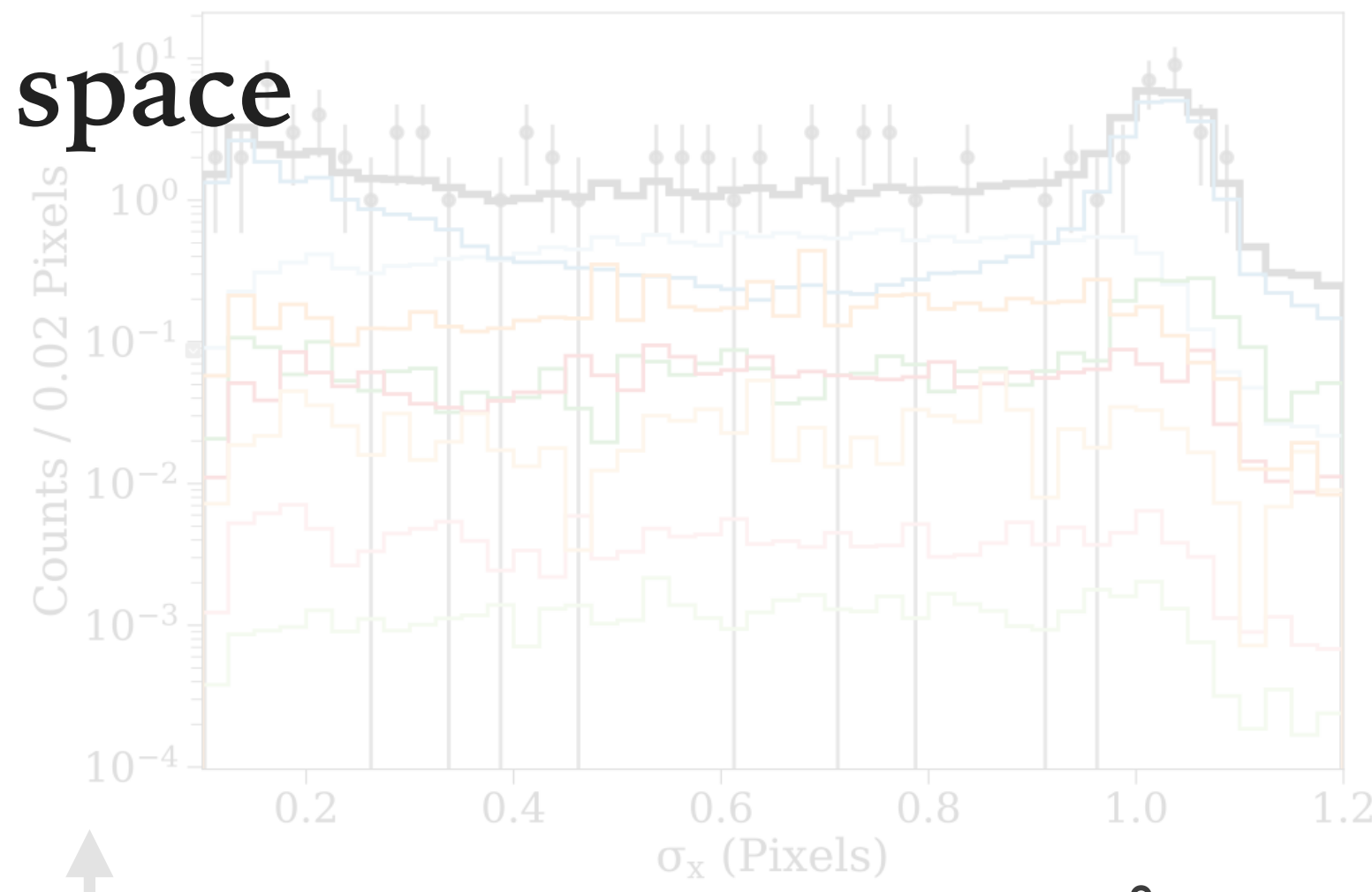
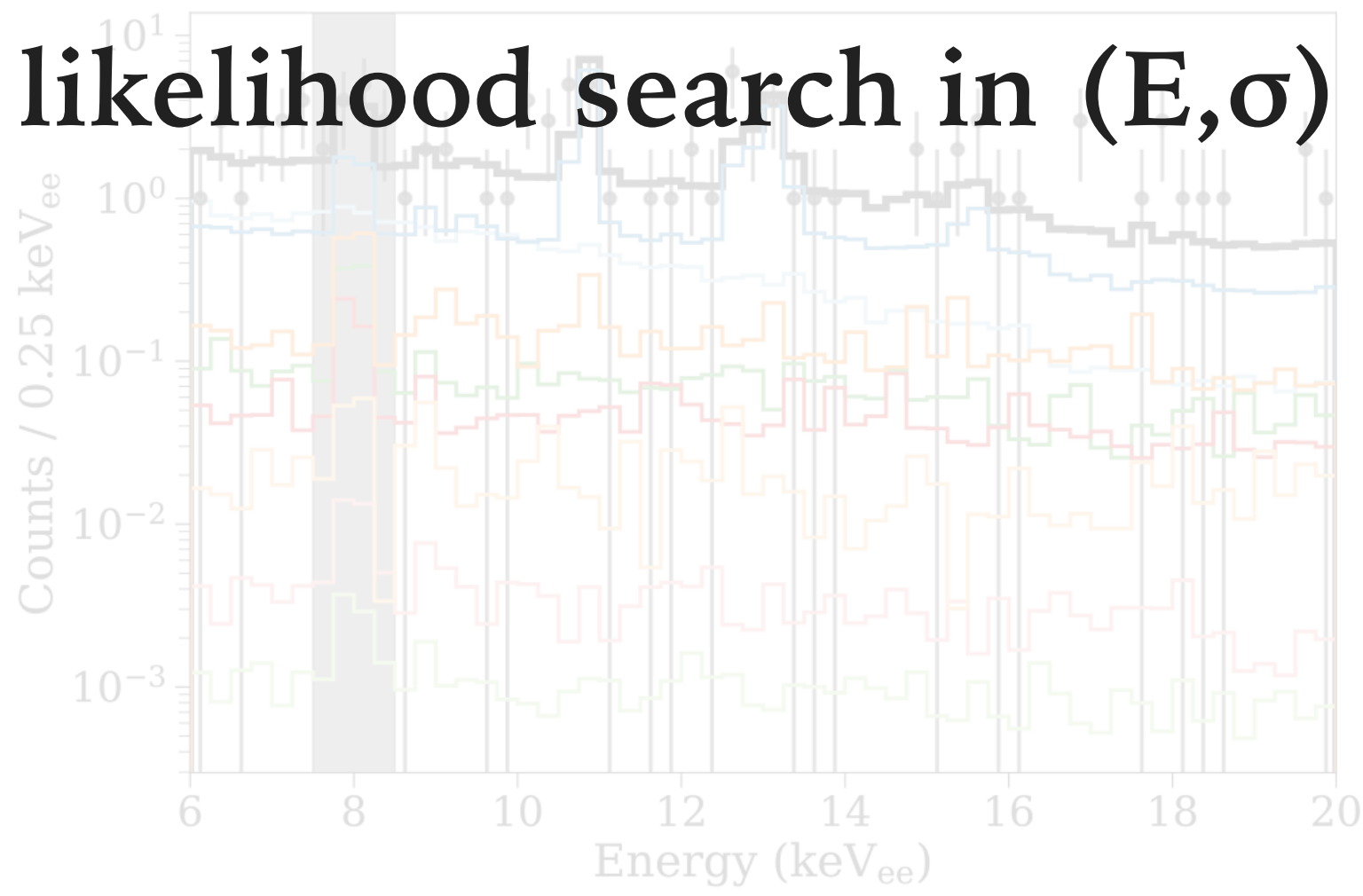
- Compare it to data bin content, k_{ij} → **Profile likelihood search in (E,σ) space**

Poisson two-dimensional likelihood analysis

→ Best-fit C_l 's characterize bkg model



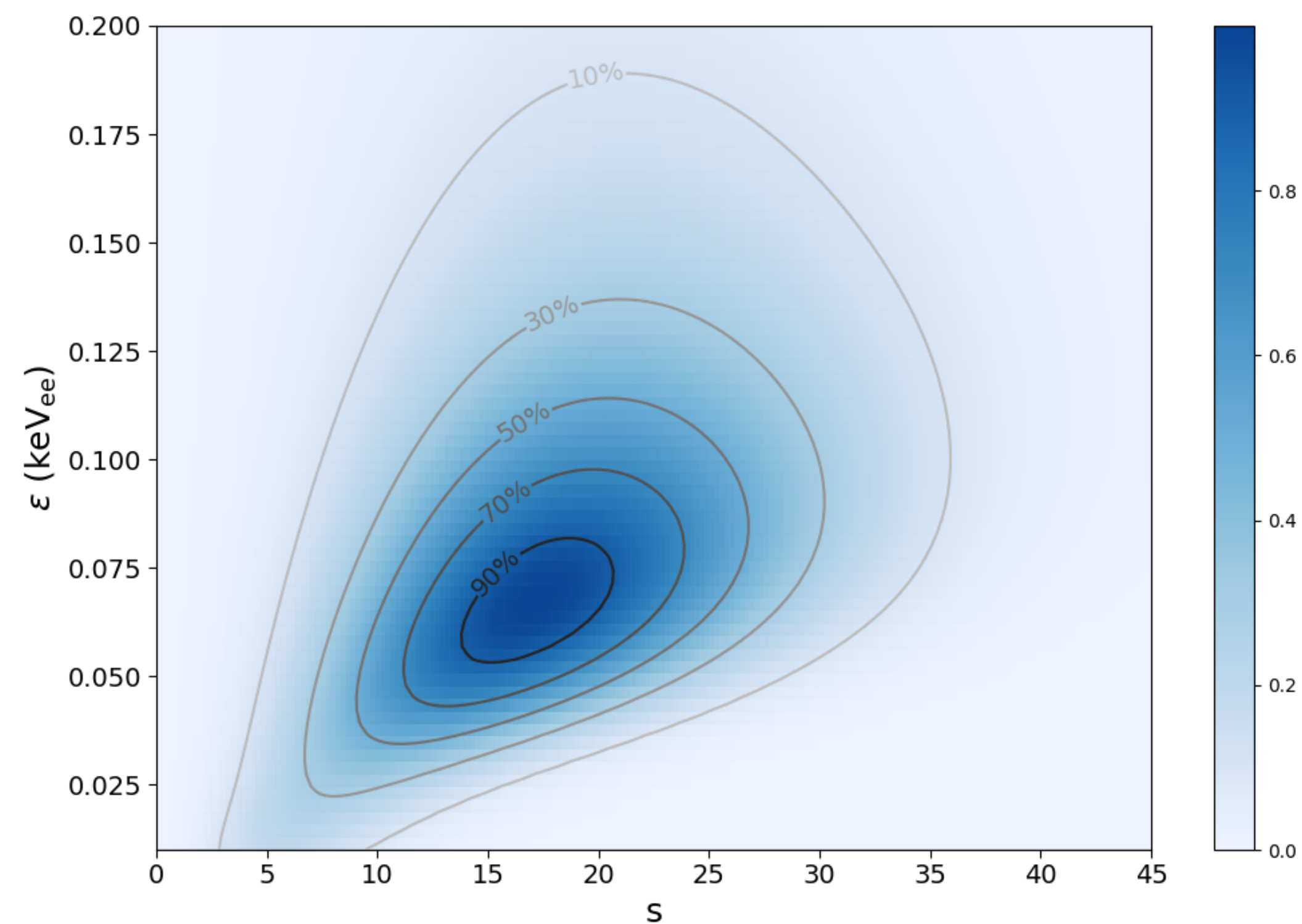
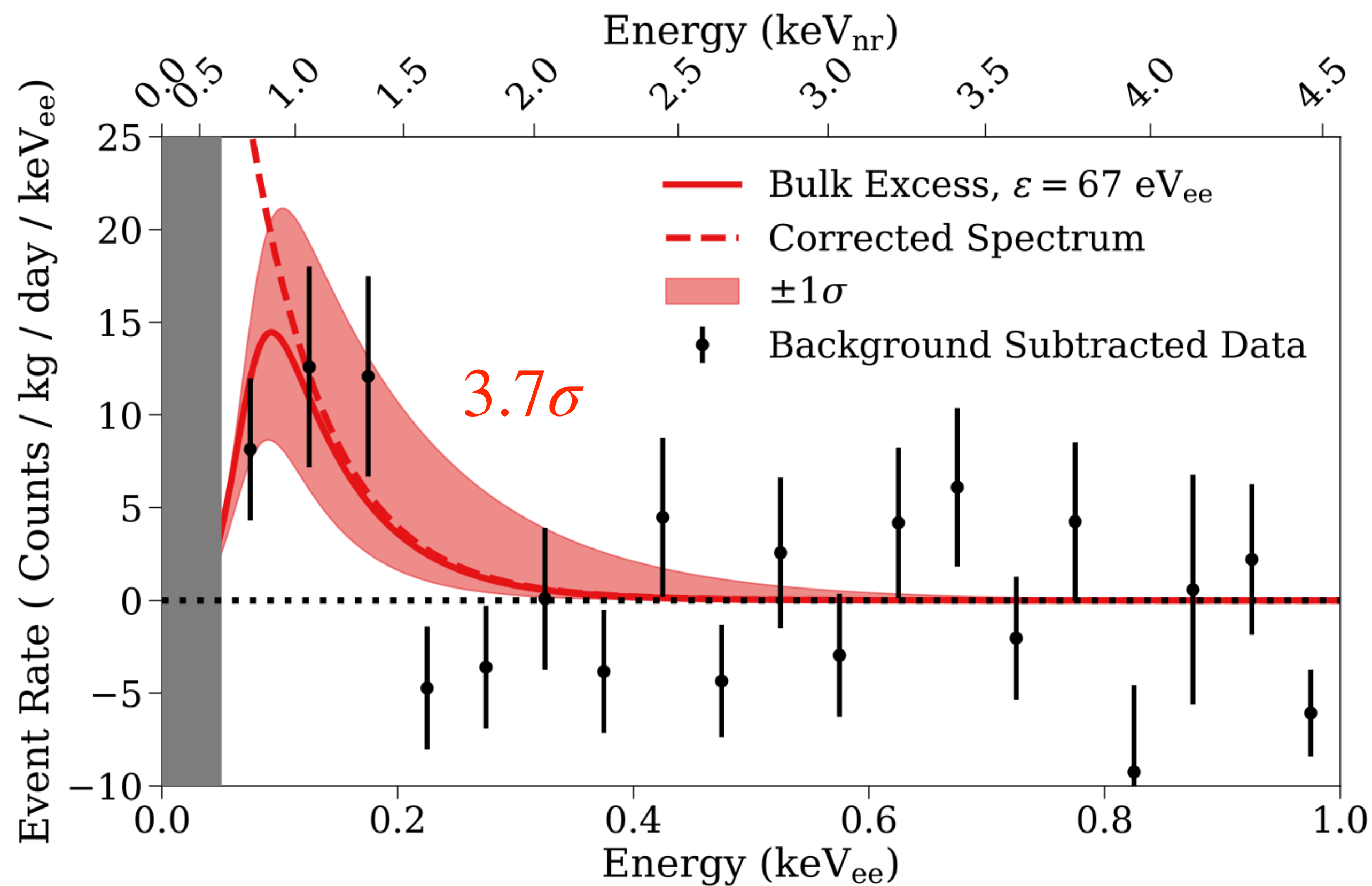
Fit on CCD 2-7 data



Validation with CCD 1 data



≤ 200 eV EXCESS



Phys. Rev. Lett. 125, 241803

Systematic checks: no issue with analysis

Plausible interpretations:

- Unaccounted detector surface effect
- Missing component in background model



DAMIC AT MODANE (DAMIC-M)

Experiment will be deployed at Modane Underground Laboratory (LSM), France.

Main novelties:

- kg-scale detector (~ 200 CCDs)
- Skipper readout: sub-electron resolution $\sim 0.1 e^-$
- $\sim 100 \times$ lower backgrounds: 10 dru $\rightarrow \mathcal{O}(0.1)$ dru

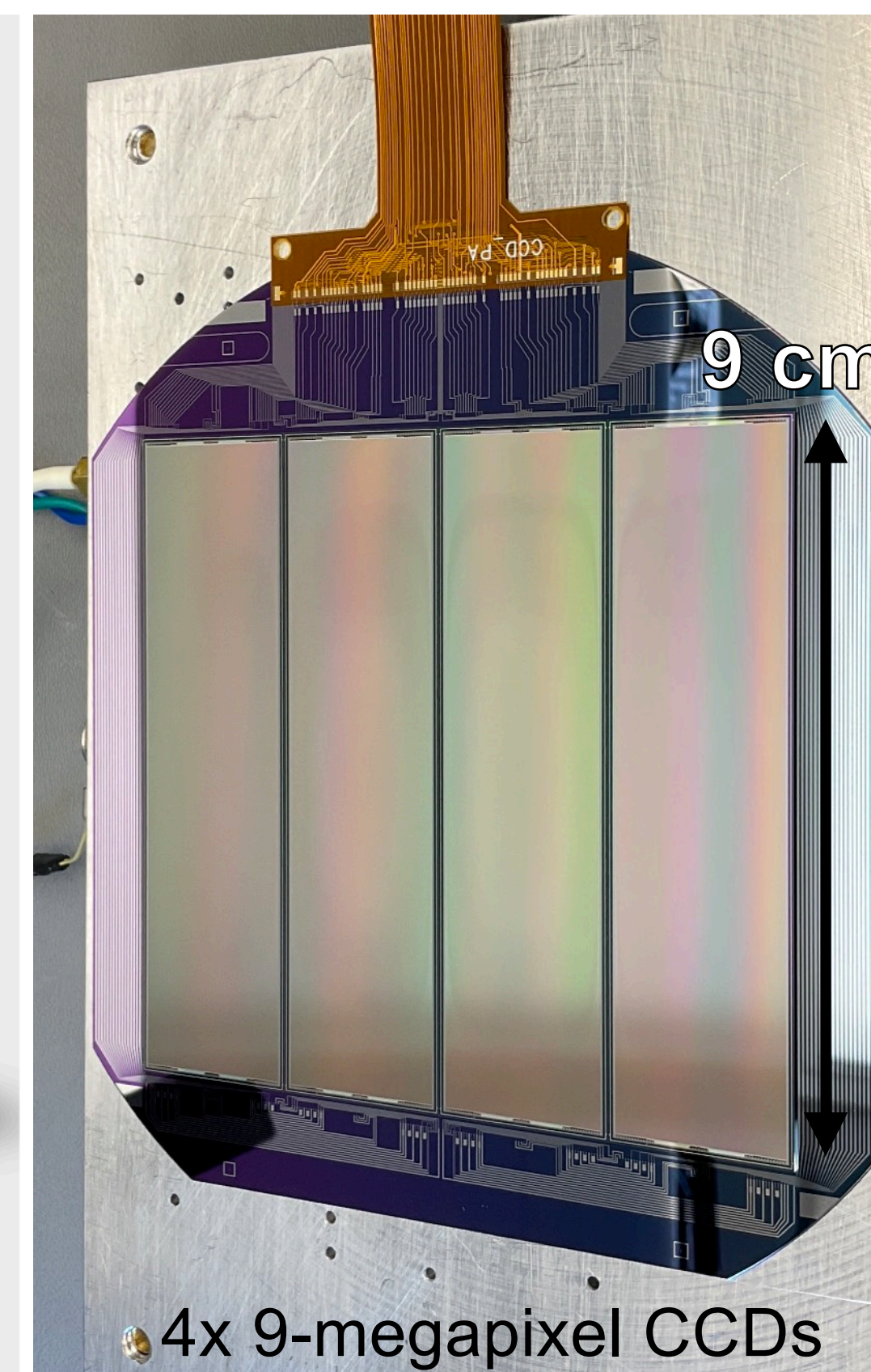
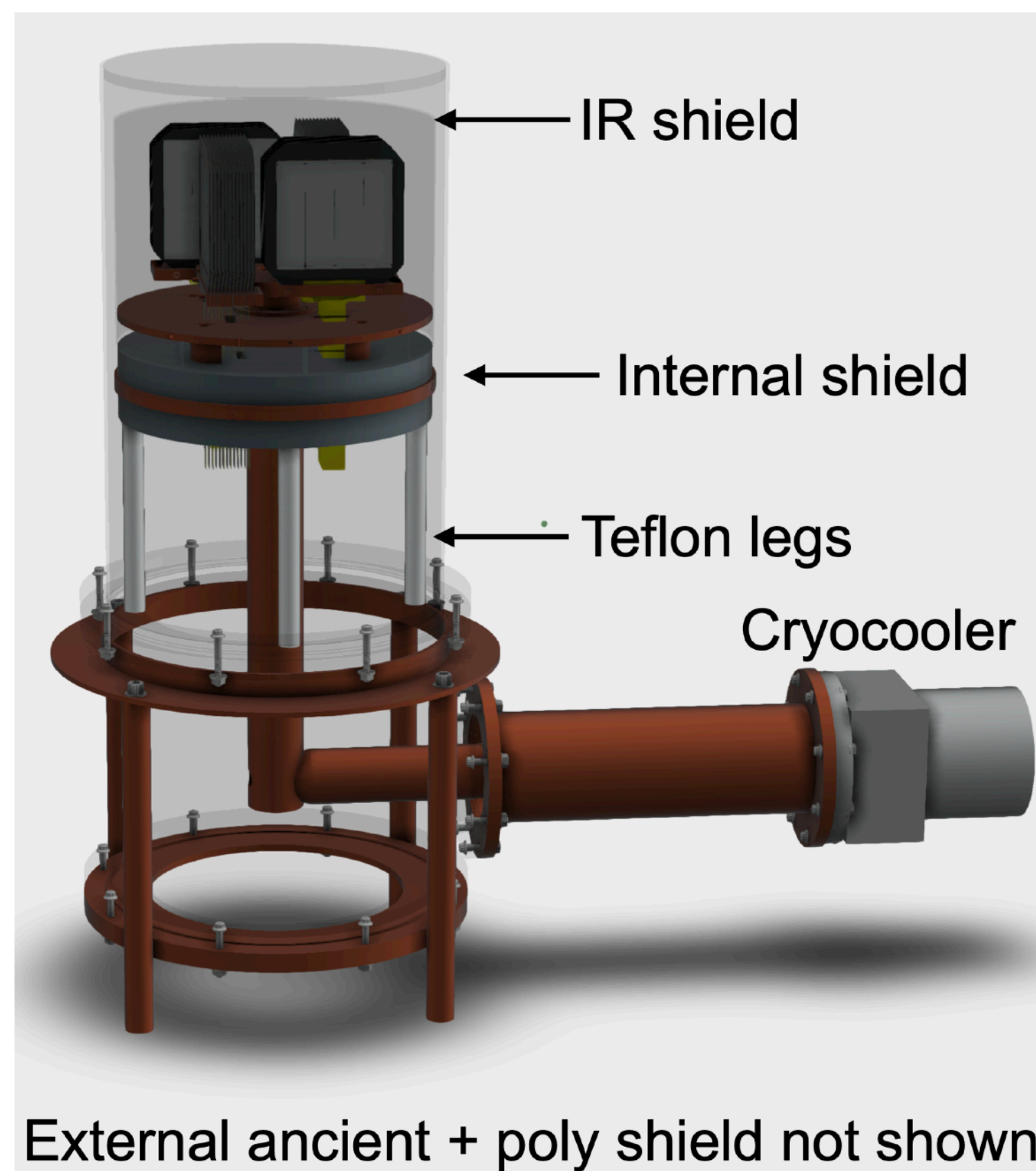
Status:

- LBC prototype detector up and running. First DAMIC-M science results published recently

Phys. Rev. Lett. 130, 171003
See JP Zopounidis presentation

- Construction starting in 2024

Nucl.Instrum.Meth.A 958 (2020) 162933

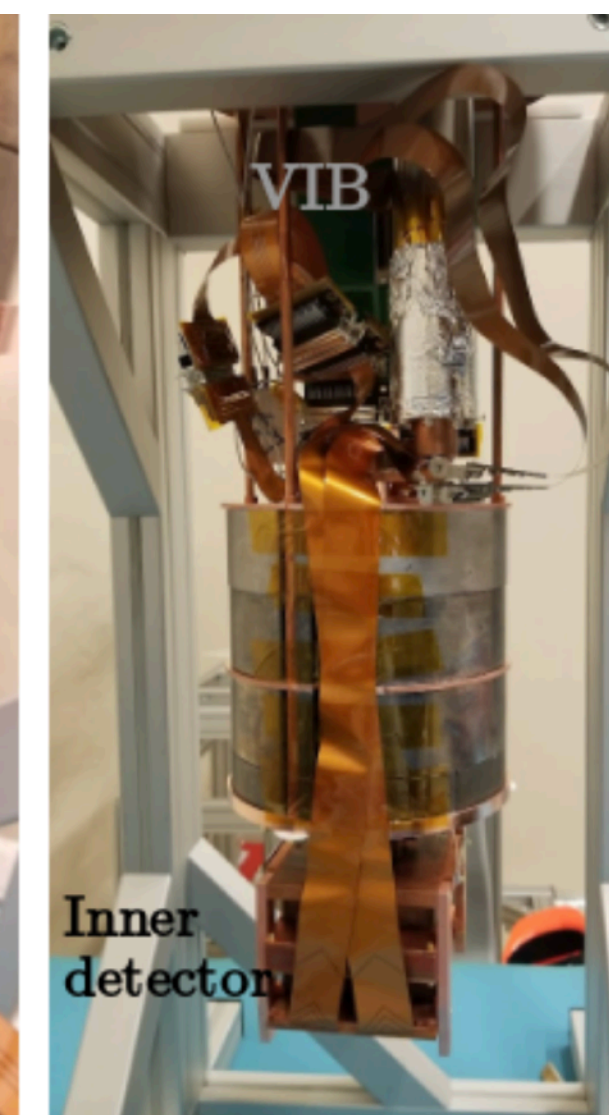
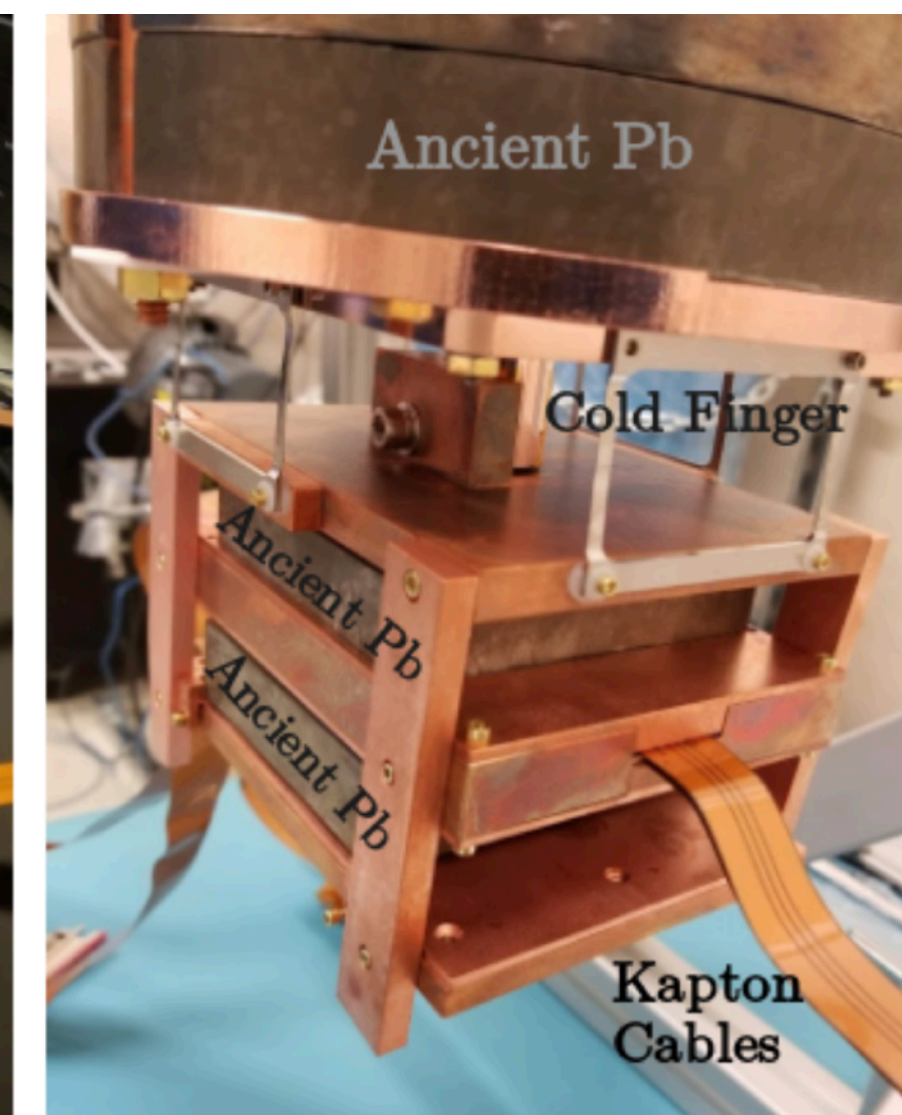
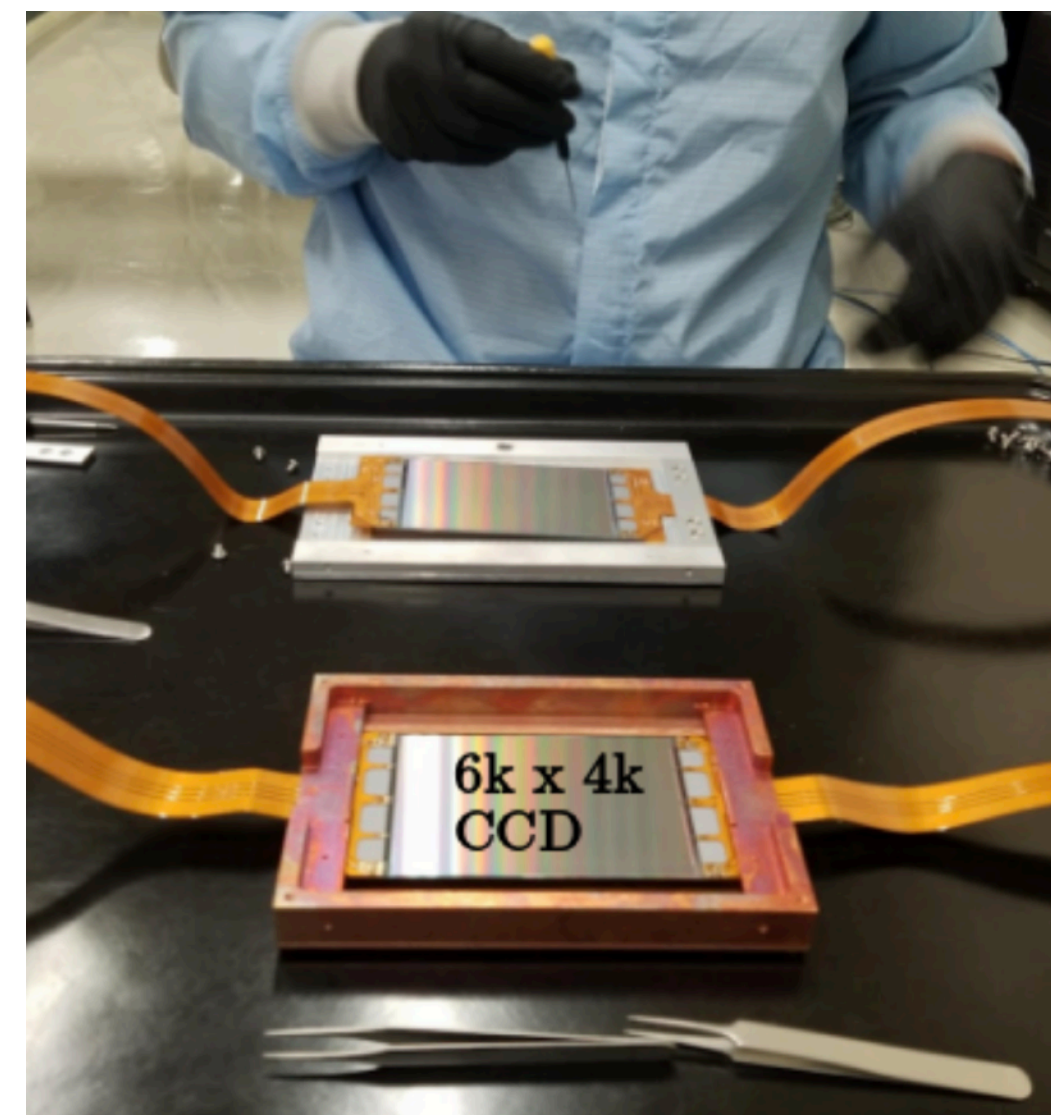


DAMIC-M CCD module packaged at UW

SKIPPER UPGRADE AT SNOLAB

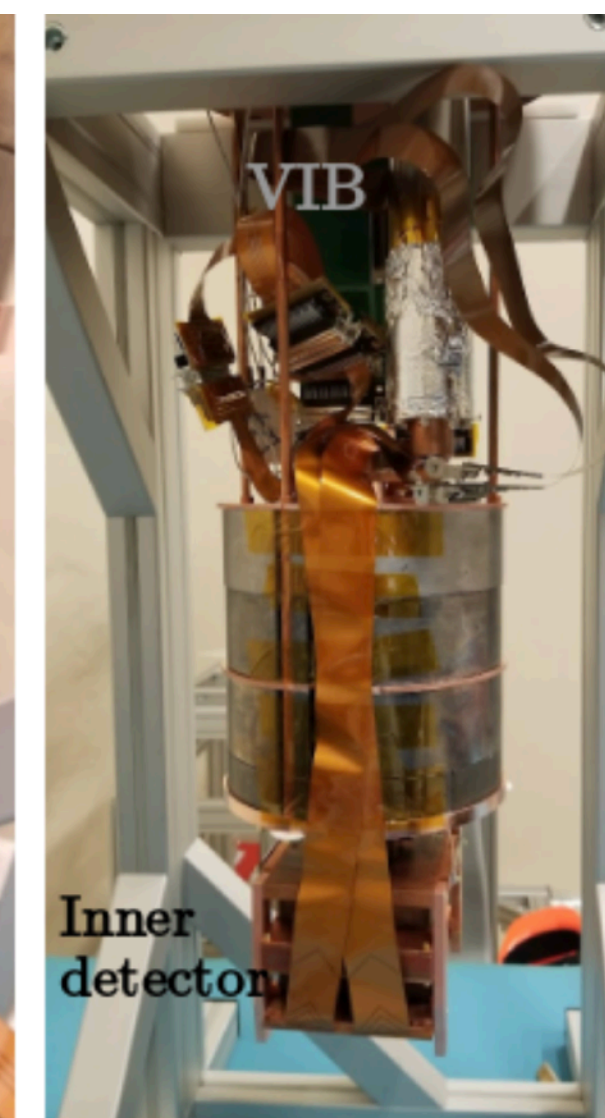
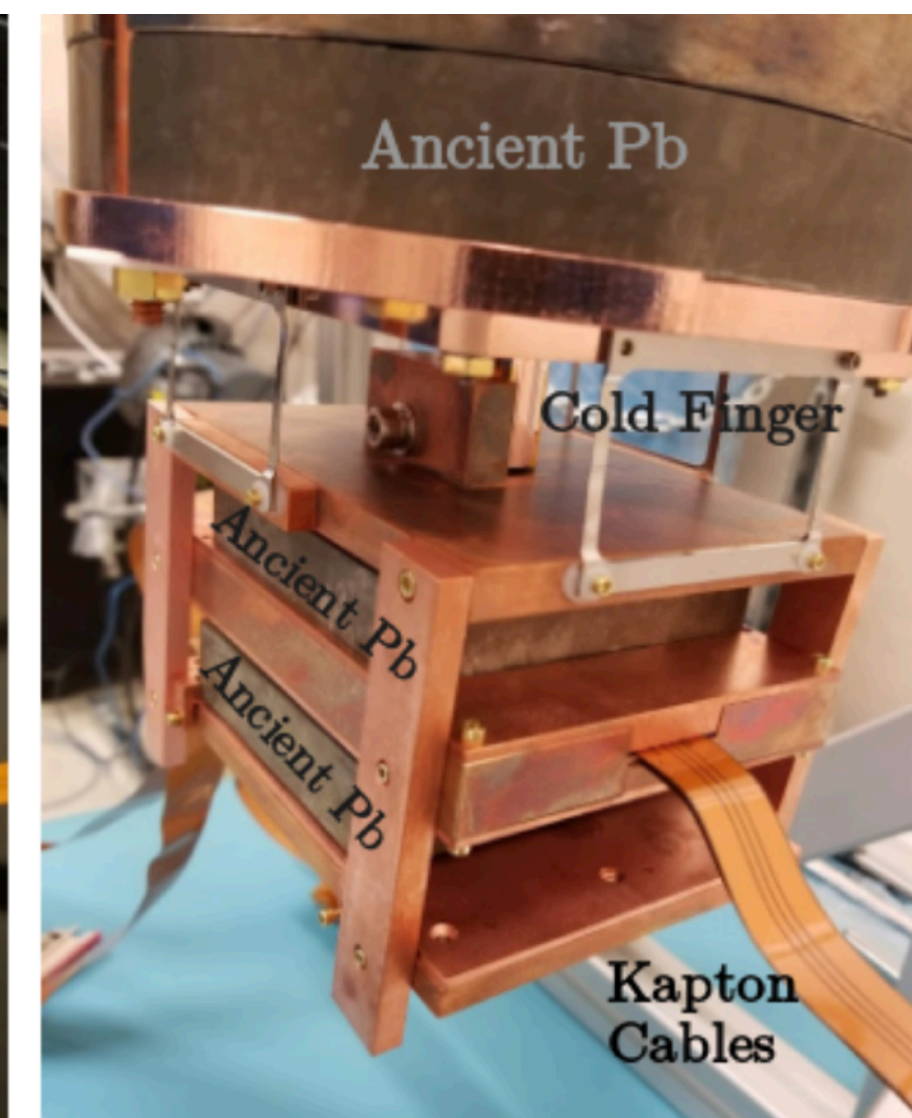
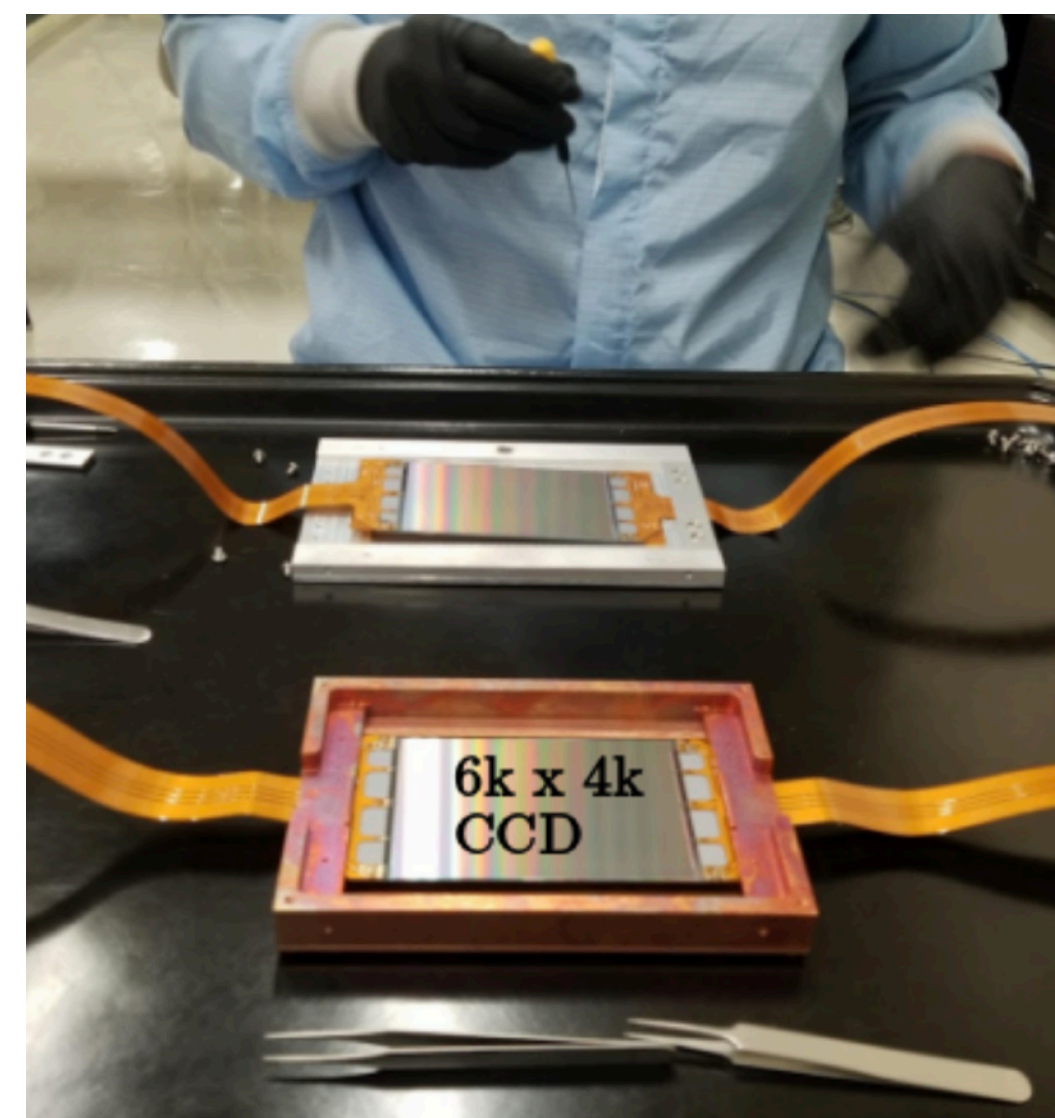
Setup upgraded with two $6k \times 4k$ skipper CCDs

- Same bkg contributions, same rate: ~ 12 dru
- $10 \times$ lower noise with skipper readout: $\sim 0.16 e^-$
- Science run from March 2022 to Jan 2023
- 4.8 kg-day total exposure. 3.1 kg-day after selections
- ROI: $E < 500 eV_{ee}$ unblinded in Feb 2023

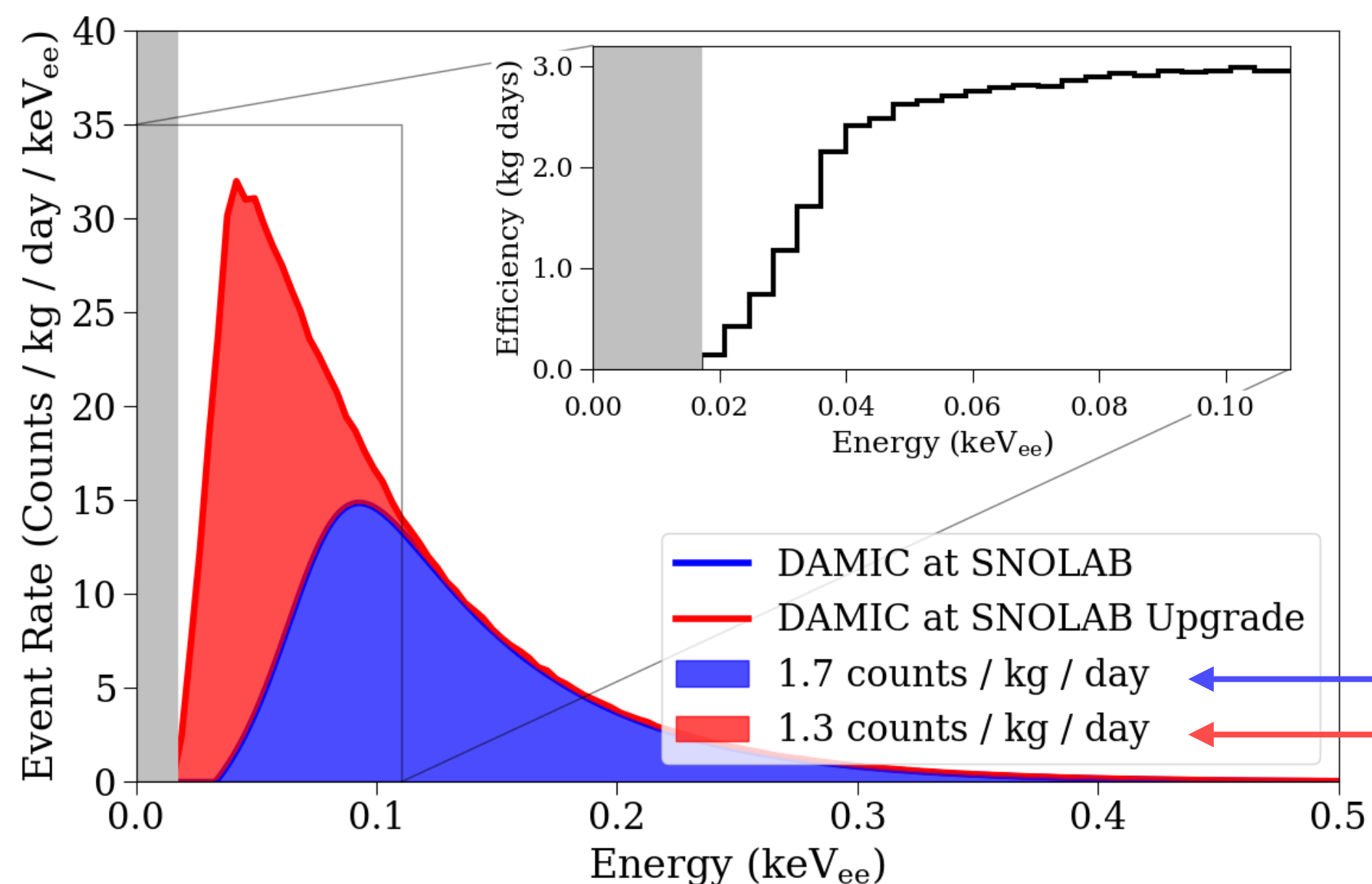


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DAMIC, DAMIC-M and SENSEI collaboration



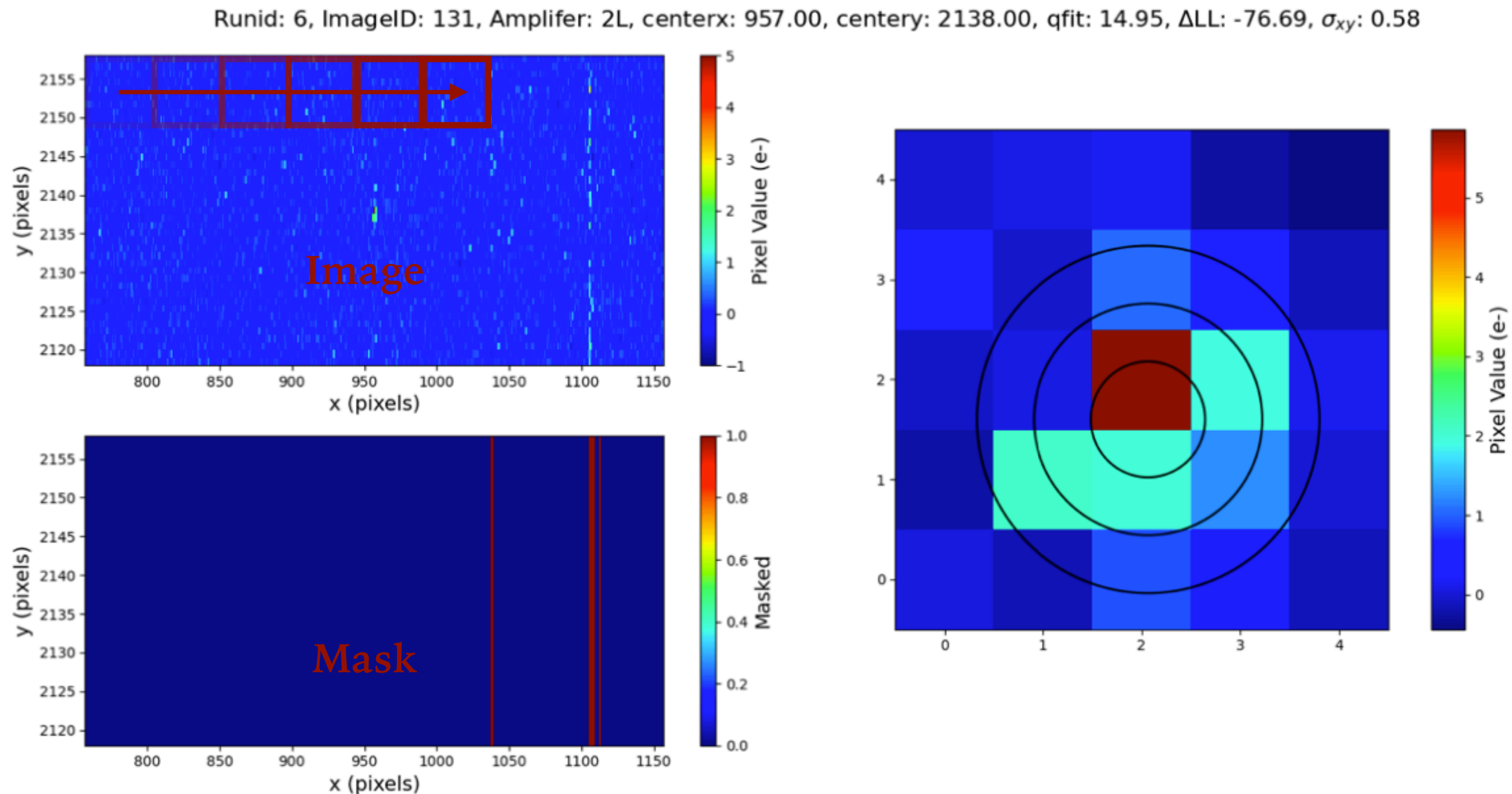
Almost twice as sensitive to previously detected excess

Detected rate in DAMIC at SNOLAB

Expected rate increase in skipper upgrade

LOW-ENERGY CLUSTERS

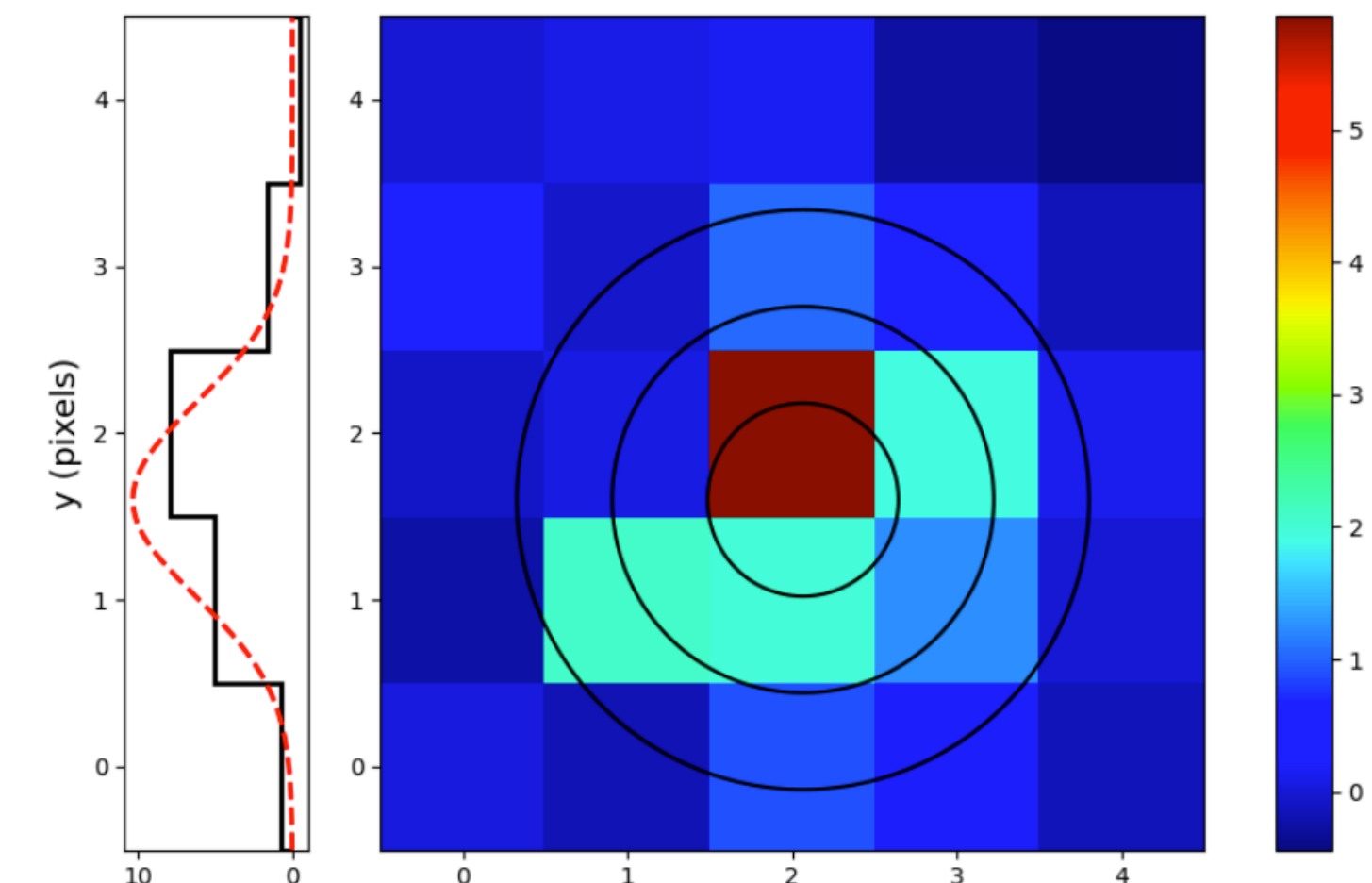
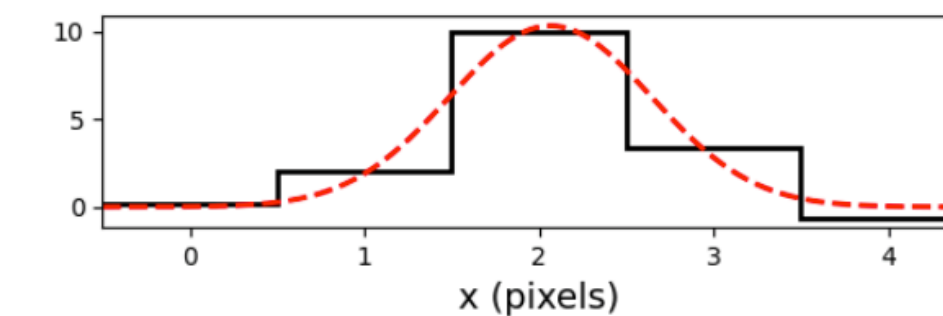
Likelihood clustering: find low-energy clusters by computing likelihood of ionization event inside **moving window**...



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$$\gamma_{ij} = \lambda_i + N \int_{i-0.5}^{i+0.5} \int_{j-0.5}^{j+0.5} \text{Gaus}(x, y | \mu_x, \mu_y, \sigma_x, \sigma_y) dx dy : \text{Noise} + \text{Ionization}$$



Likelihood clustering: ...and efficiently **reject noise accidentals** down to 23 eV_{ee}

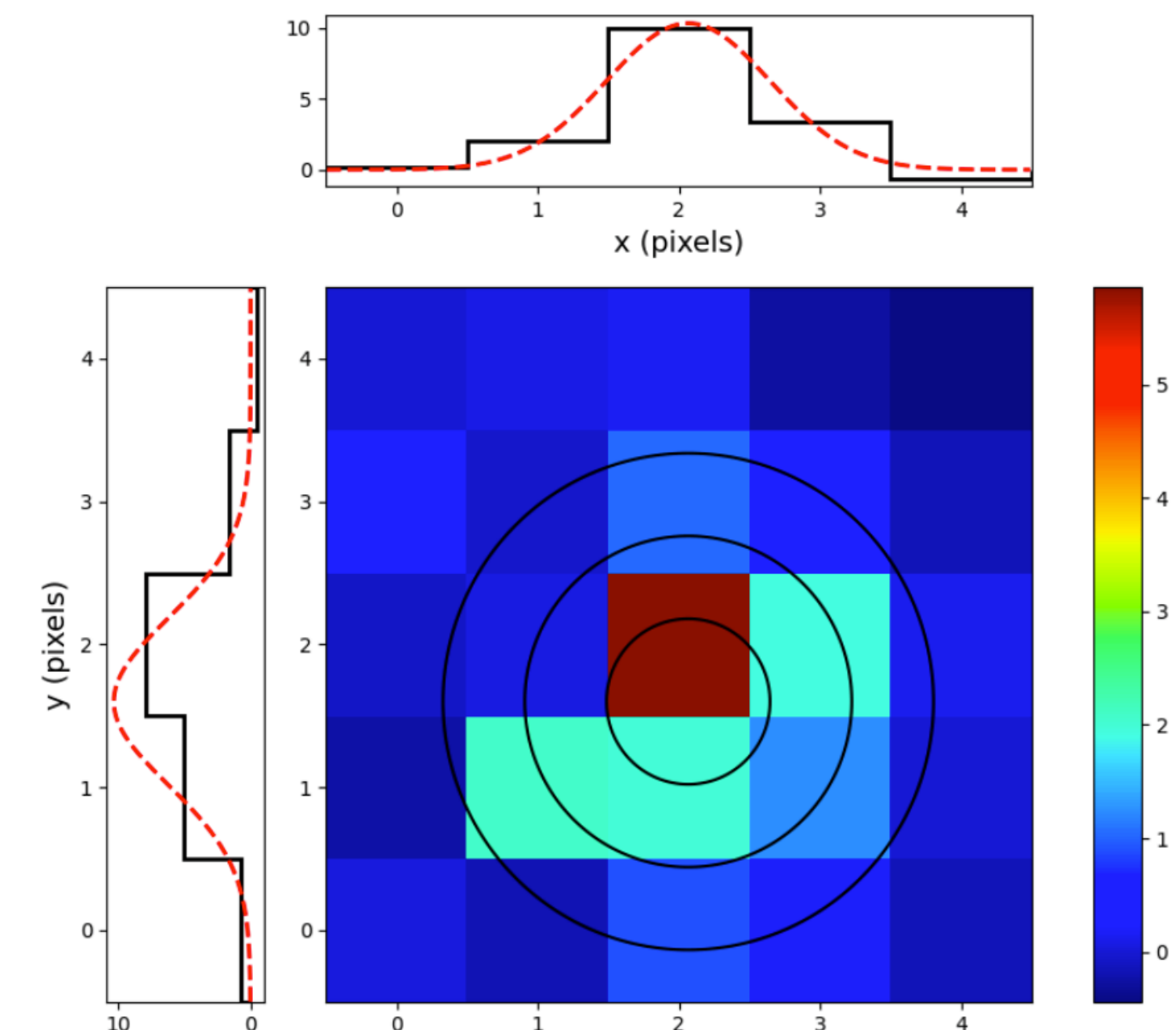
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$\tilde{\mathcal{L}}_g$: global likelihood under hypothesis of ionization

\mathcal{L}_n : local likelihood under noise-only hypothesis



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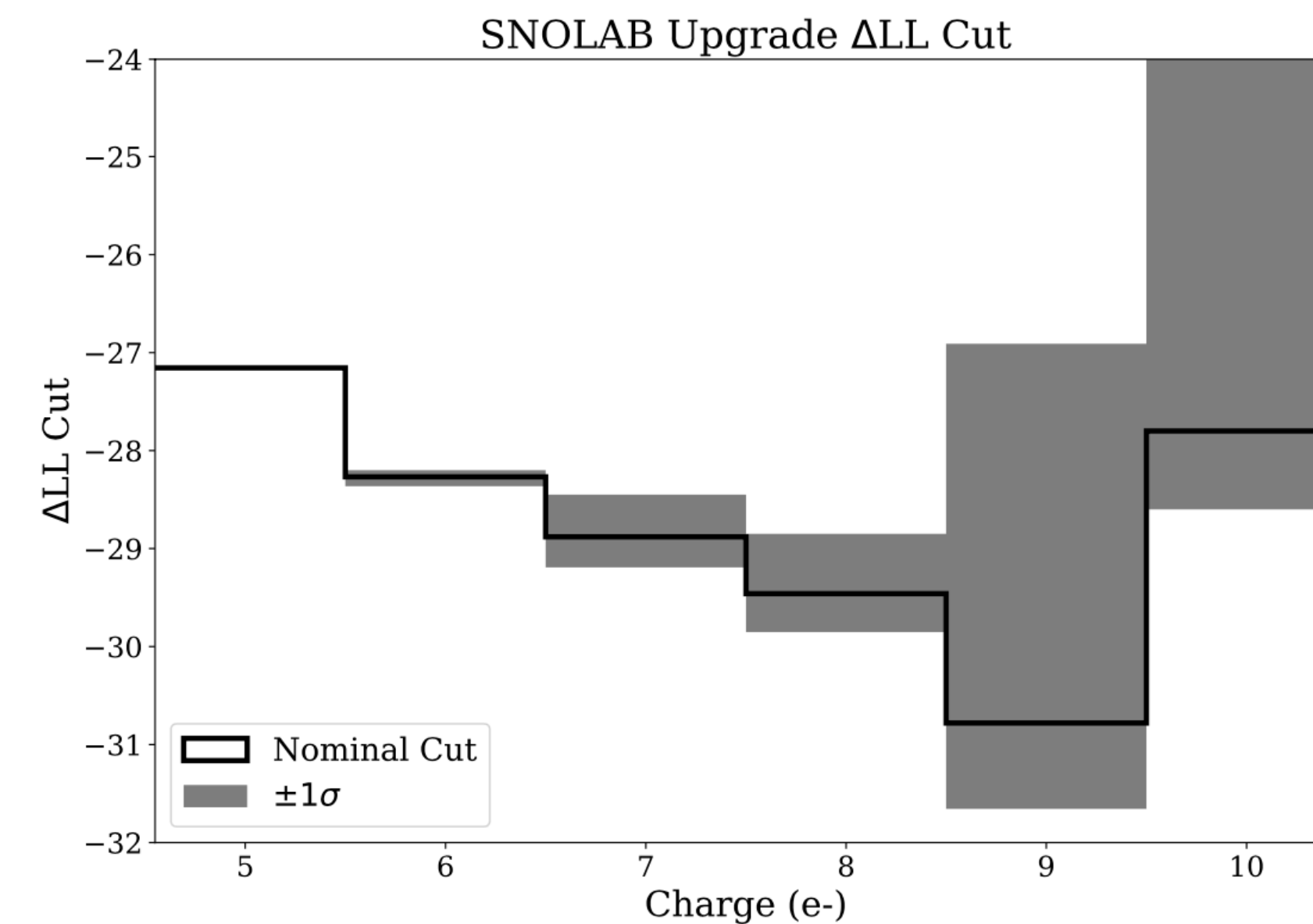
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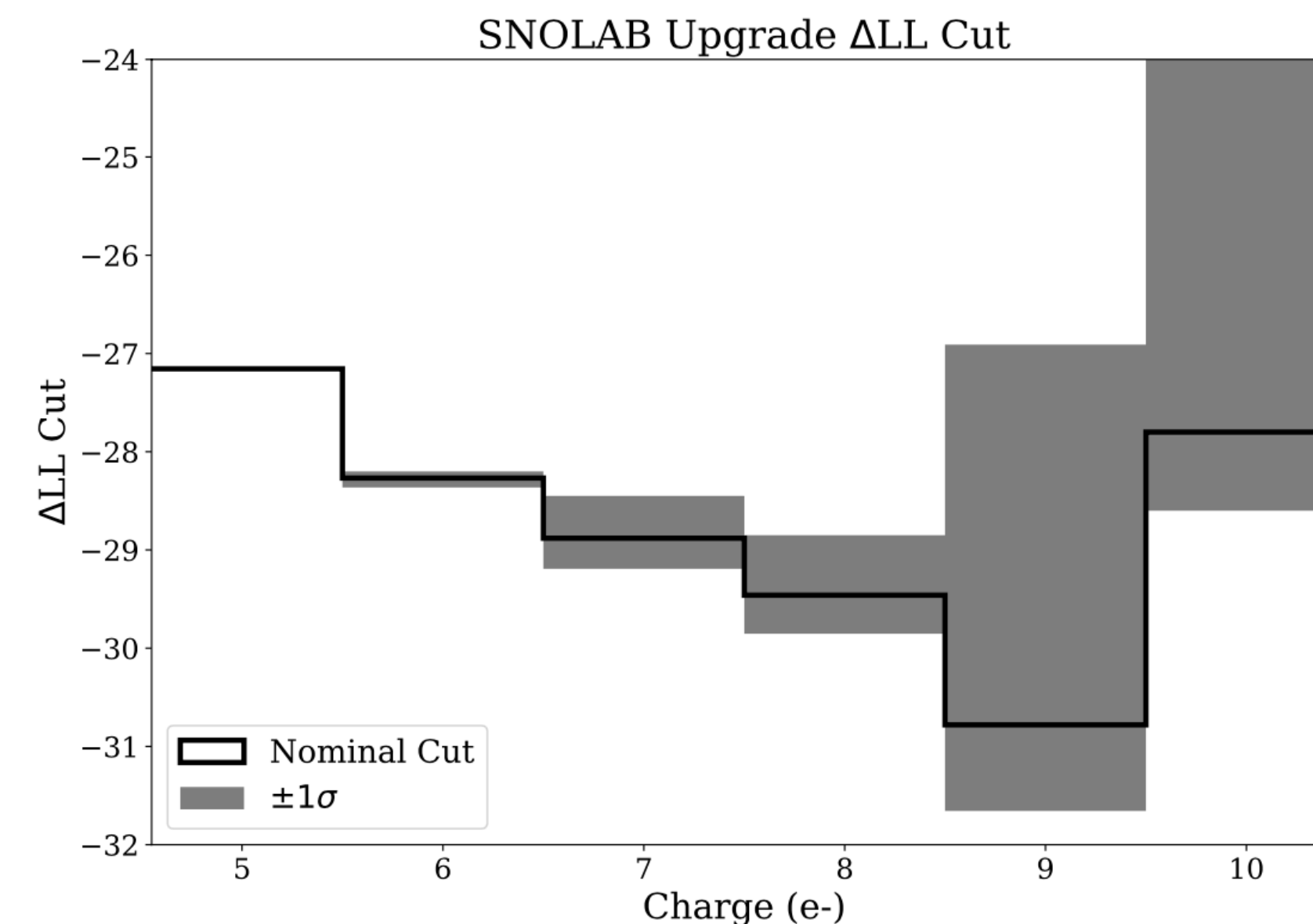


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Bulk fiducialization: we also **reject CCD surface events**, the largest source of systematic uncertainty

We apply a fiducial selection of bulk

events, **using the diffusion model**:

$$\sigma_{xy}(z, E) = \sqrt{-A \ln(1 - bz)} (\alpha + \beta E)$$

σ_{xy} : cluster spread z : depth E : energy

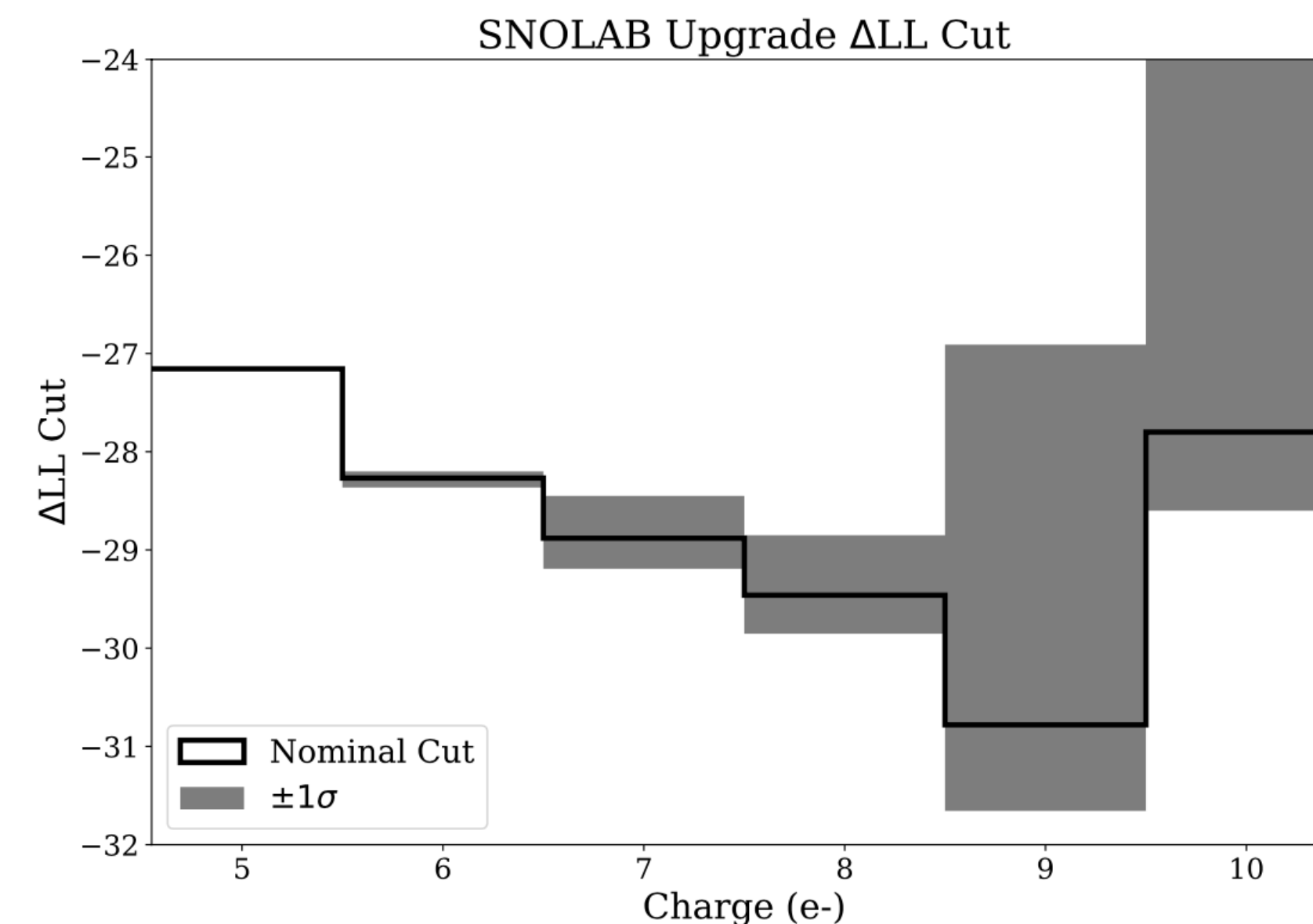
Model validated in the lab

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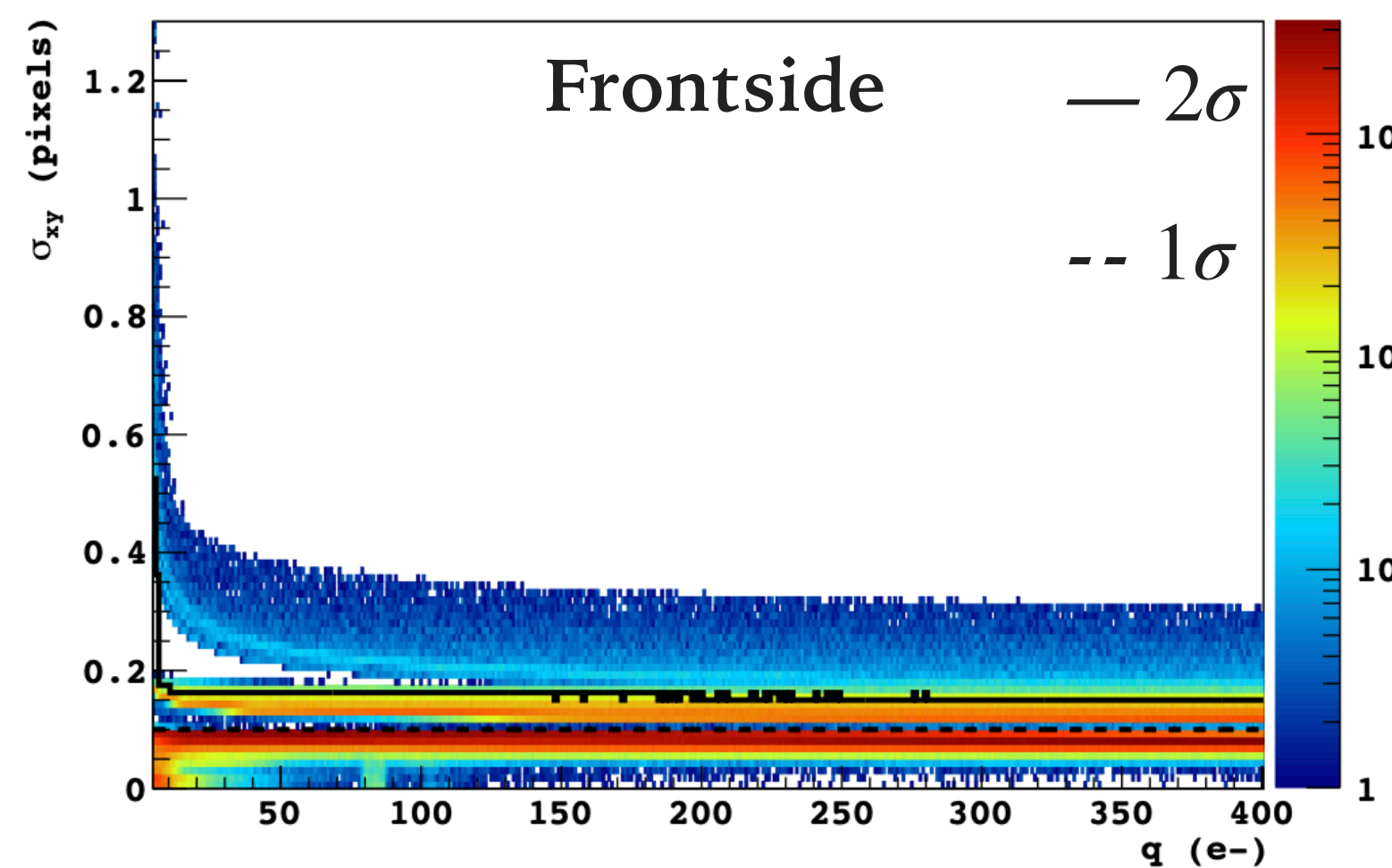
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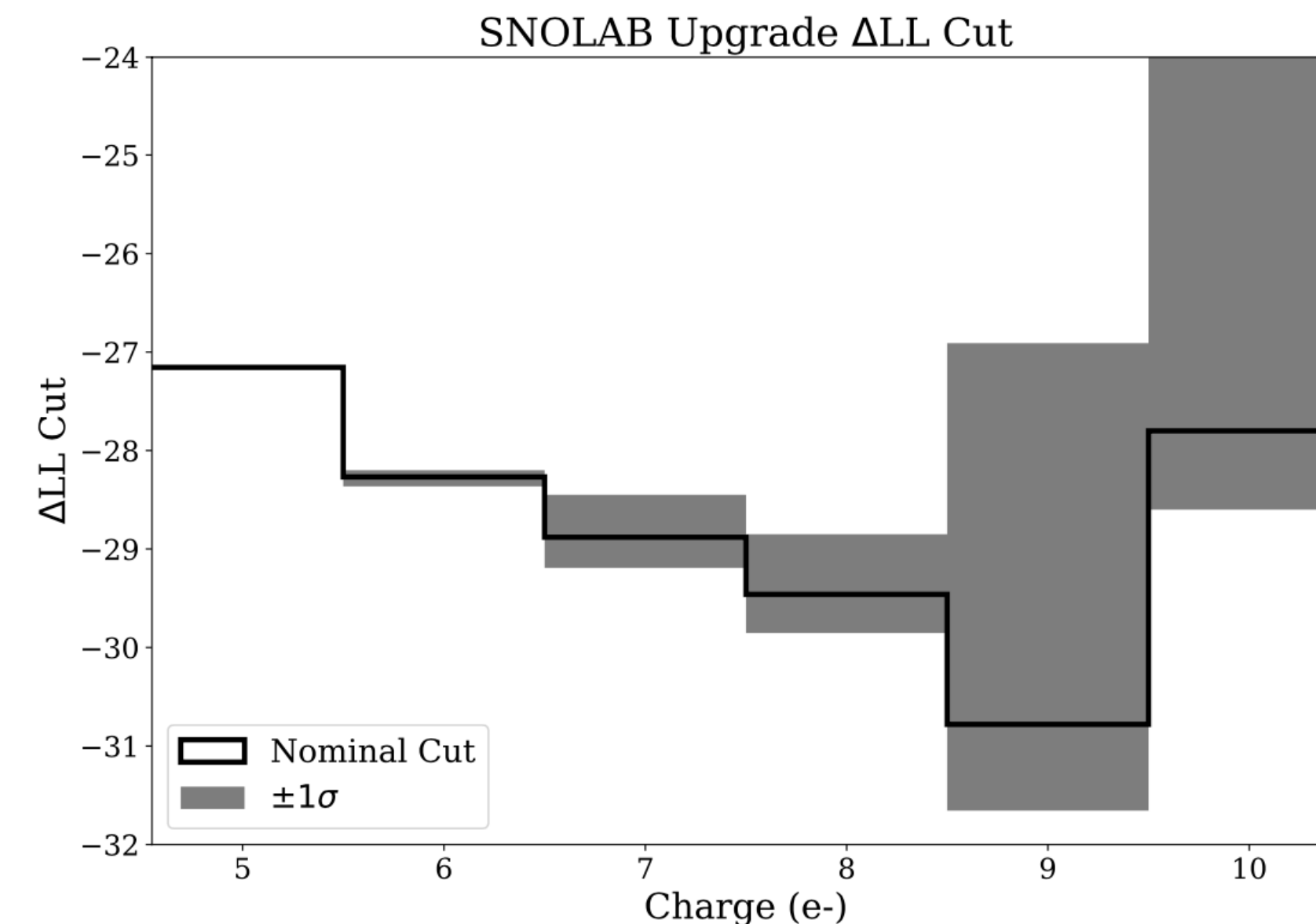


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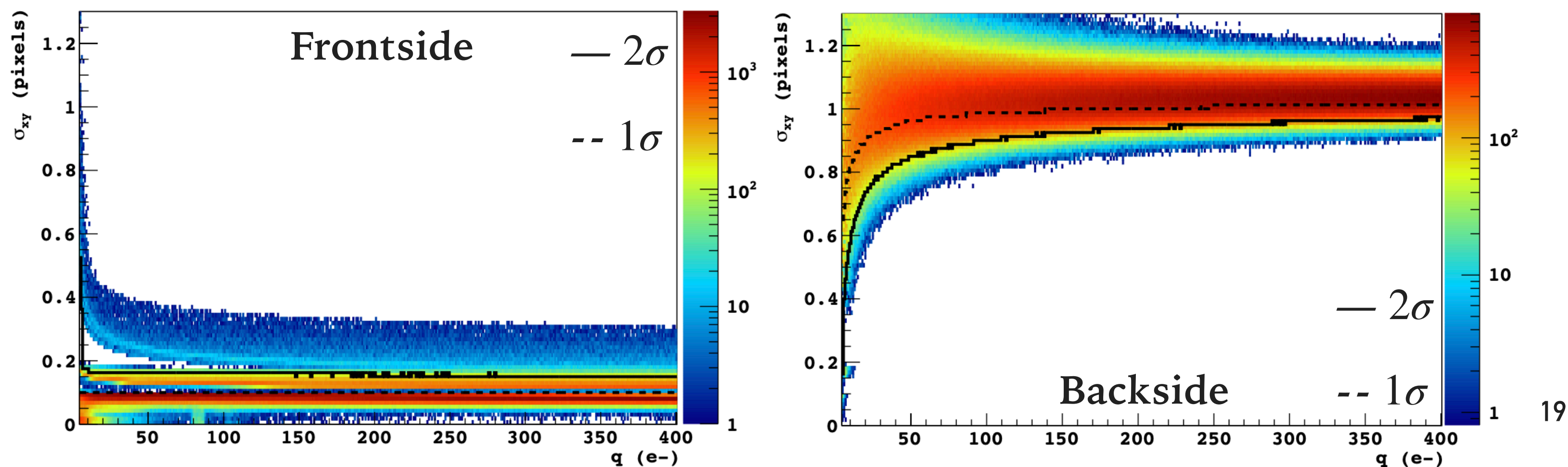
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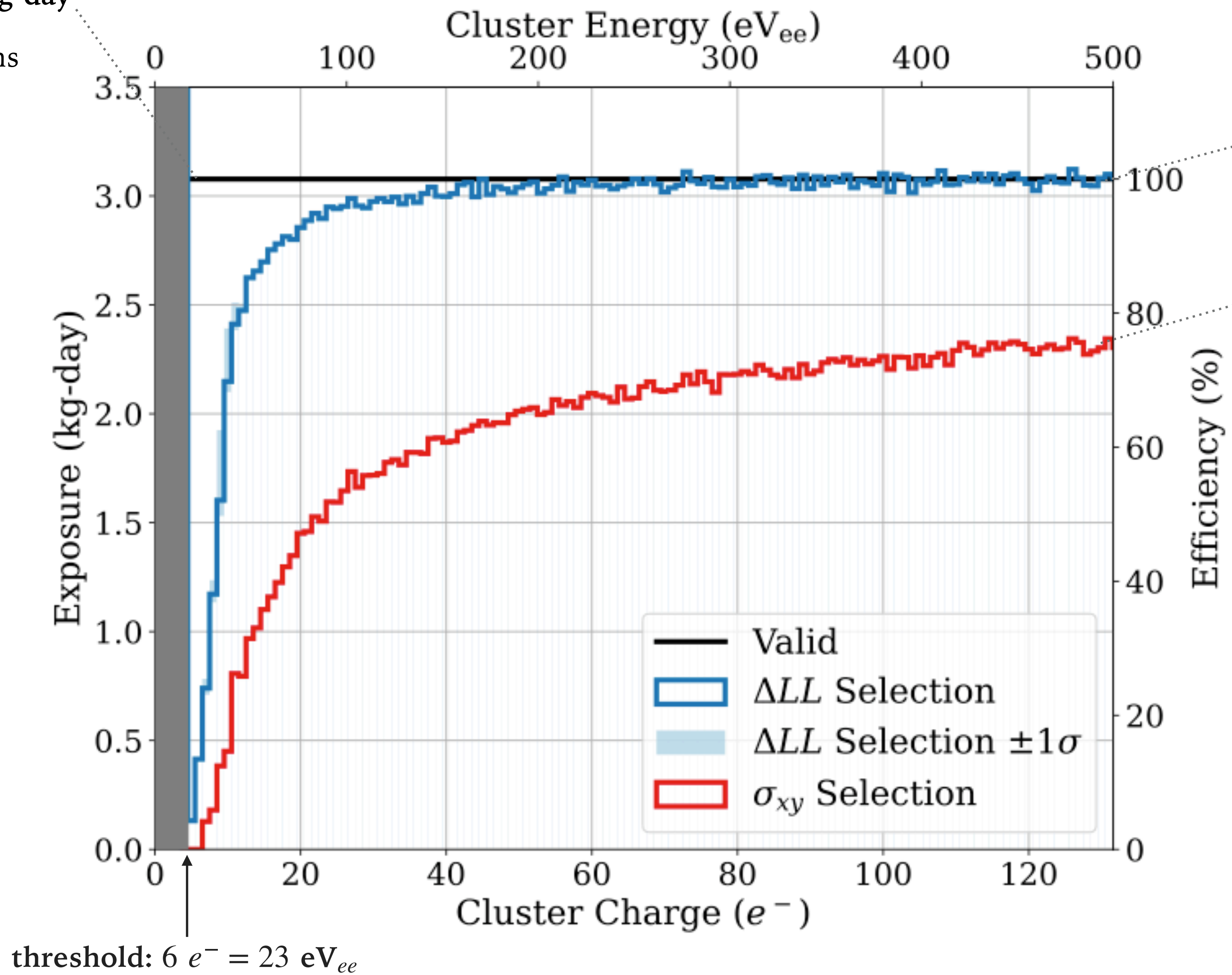
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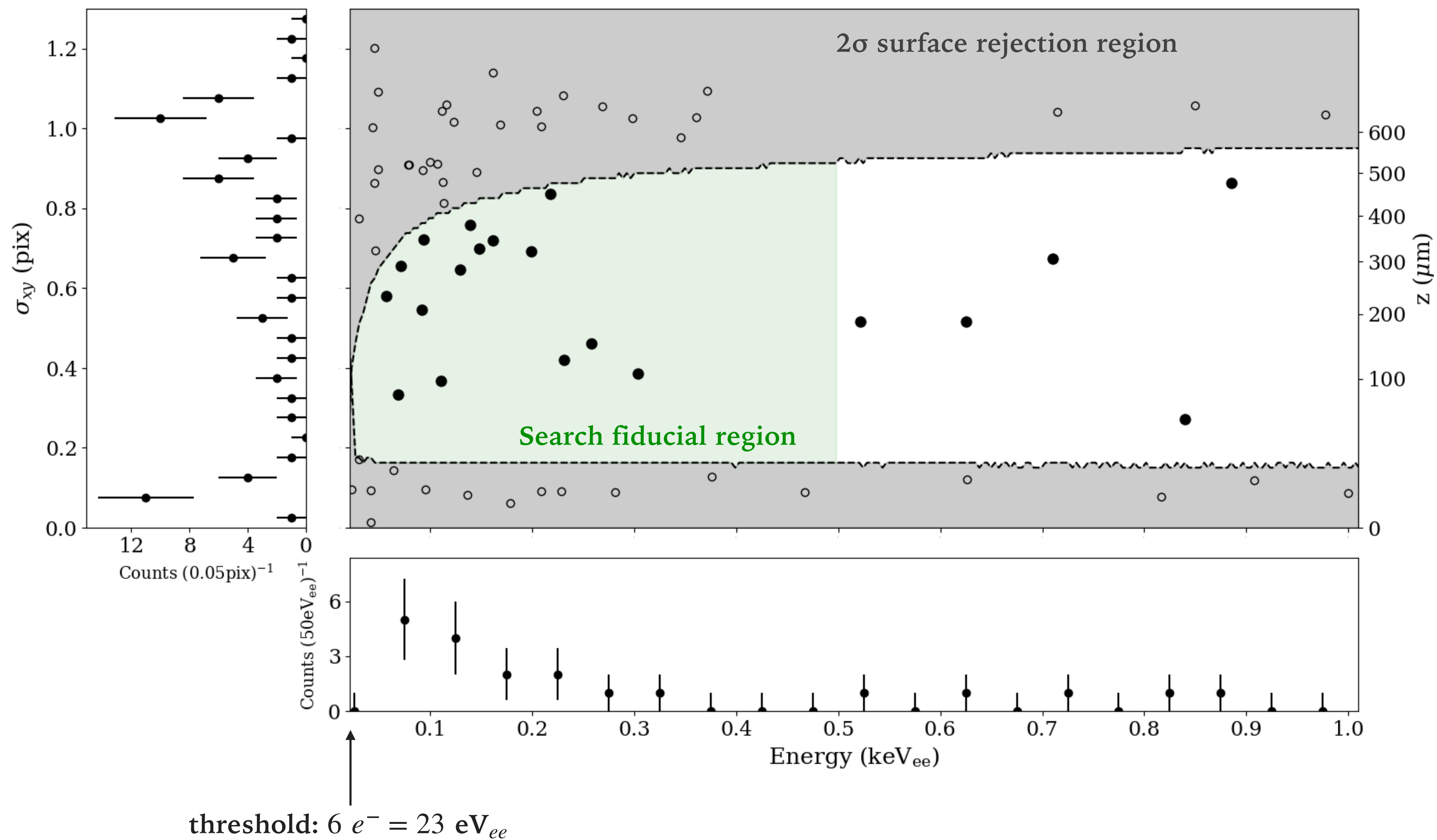
DATA SELECTIONS

Valid clusters: from 4.8 to 3.1 kg-day

- mask defects and hot regions
- mask high-energy clusters
- discard bad images



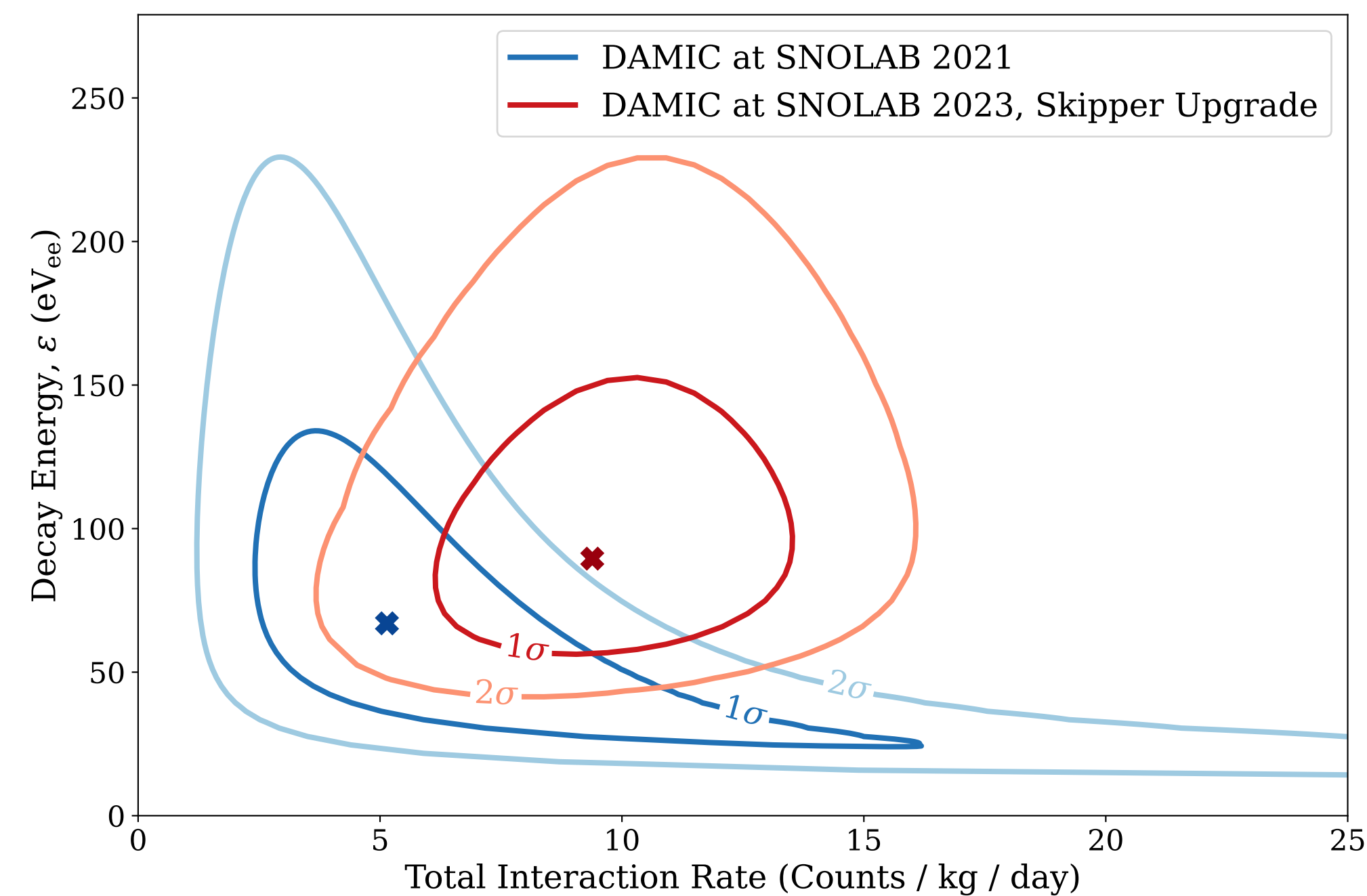
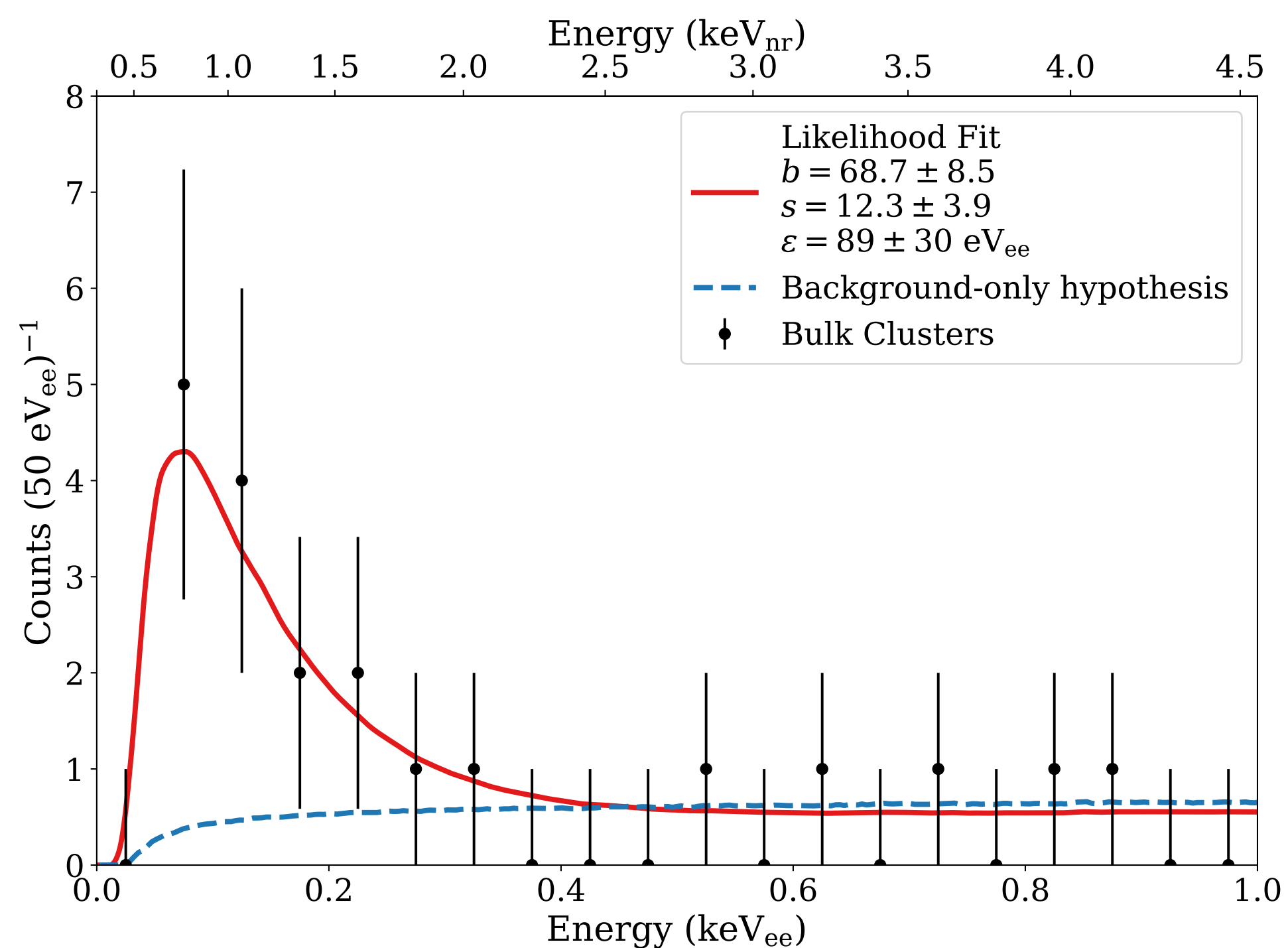
FIDUCIALIZED SCIENCE DATA



- Fit flat* bkg+exponential signal between 23 eV_{ee} and 6 keV_{ee}

The excess is still there! [arXiv:2306.01717](https://arxiv.org/abs/2306.01717)

- Increased significance: 5.4 σ (expected from lower threshold)
- Statistically compatible with old excess (see contours)

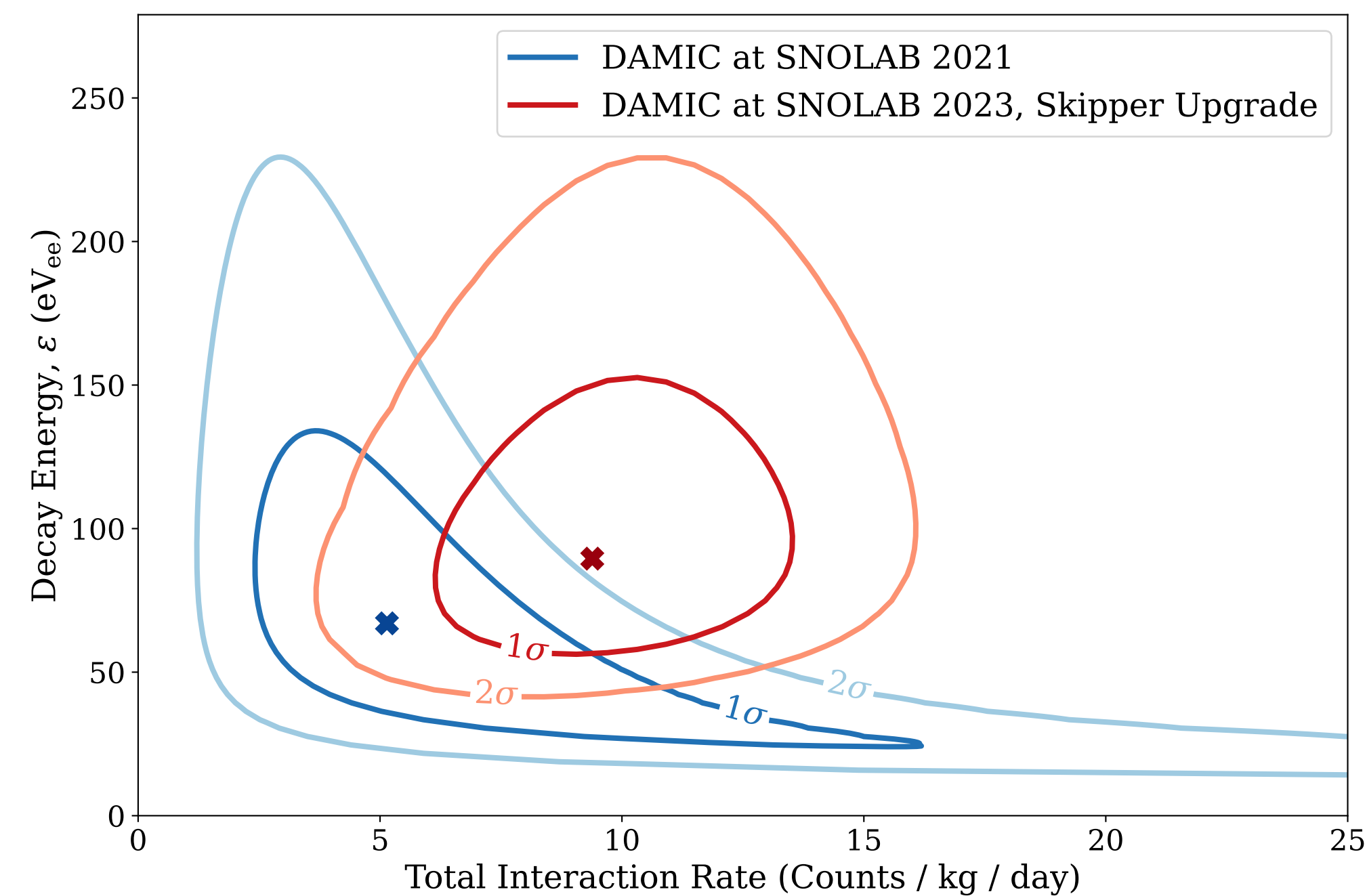
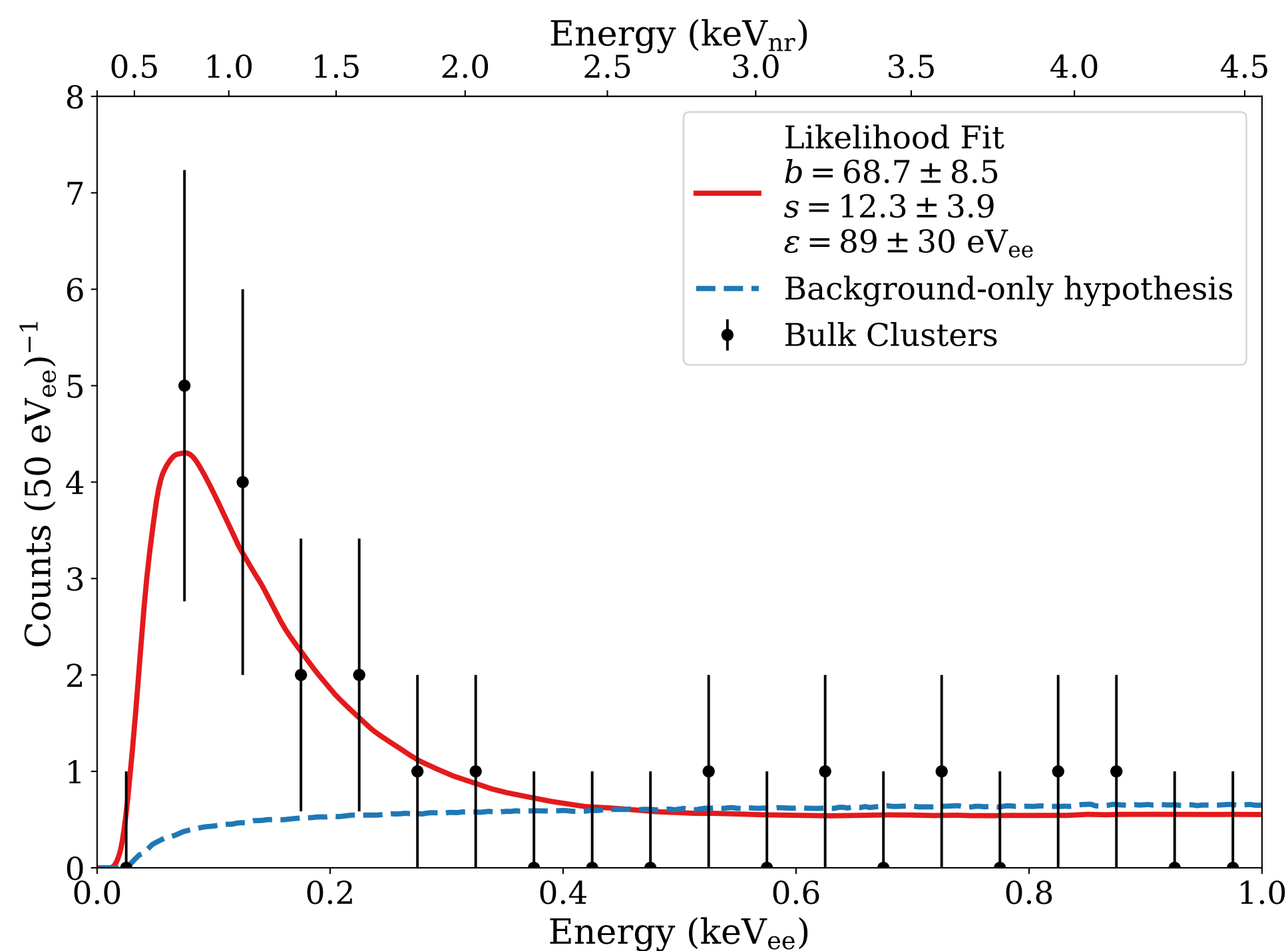


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*Flat background: conservative assumption. Near-threshold drops expected in ROI from Compton and tritium β^- events. Model re-validated above 0.5 keV



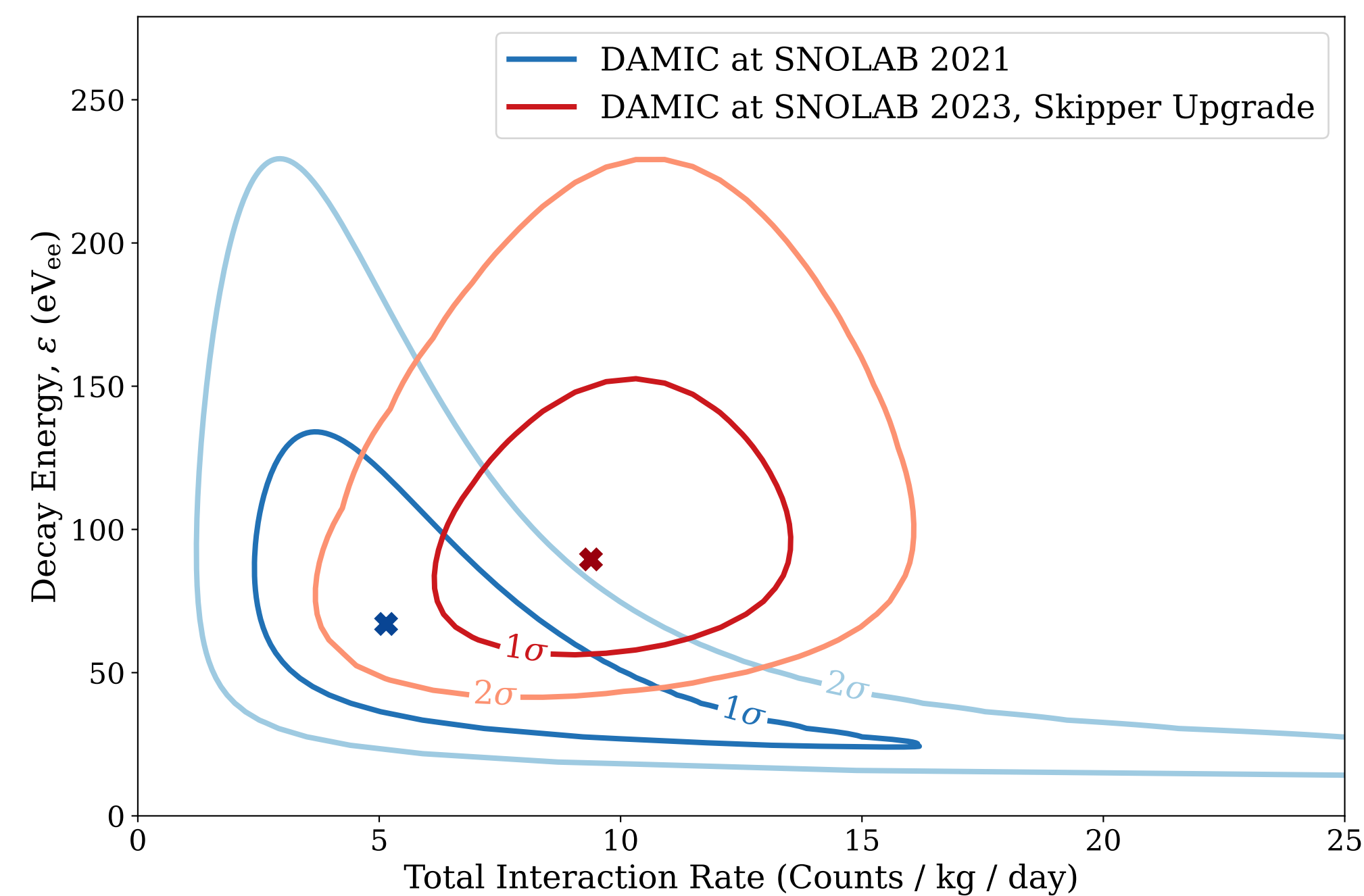
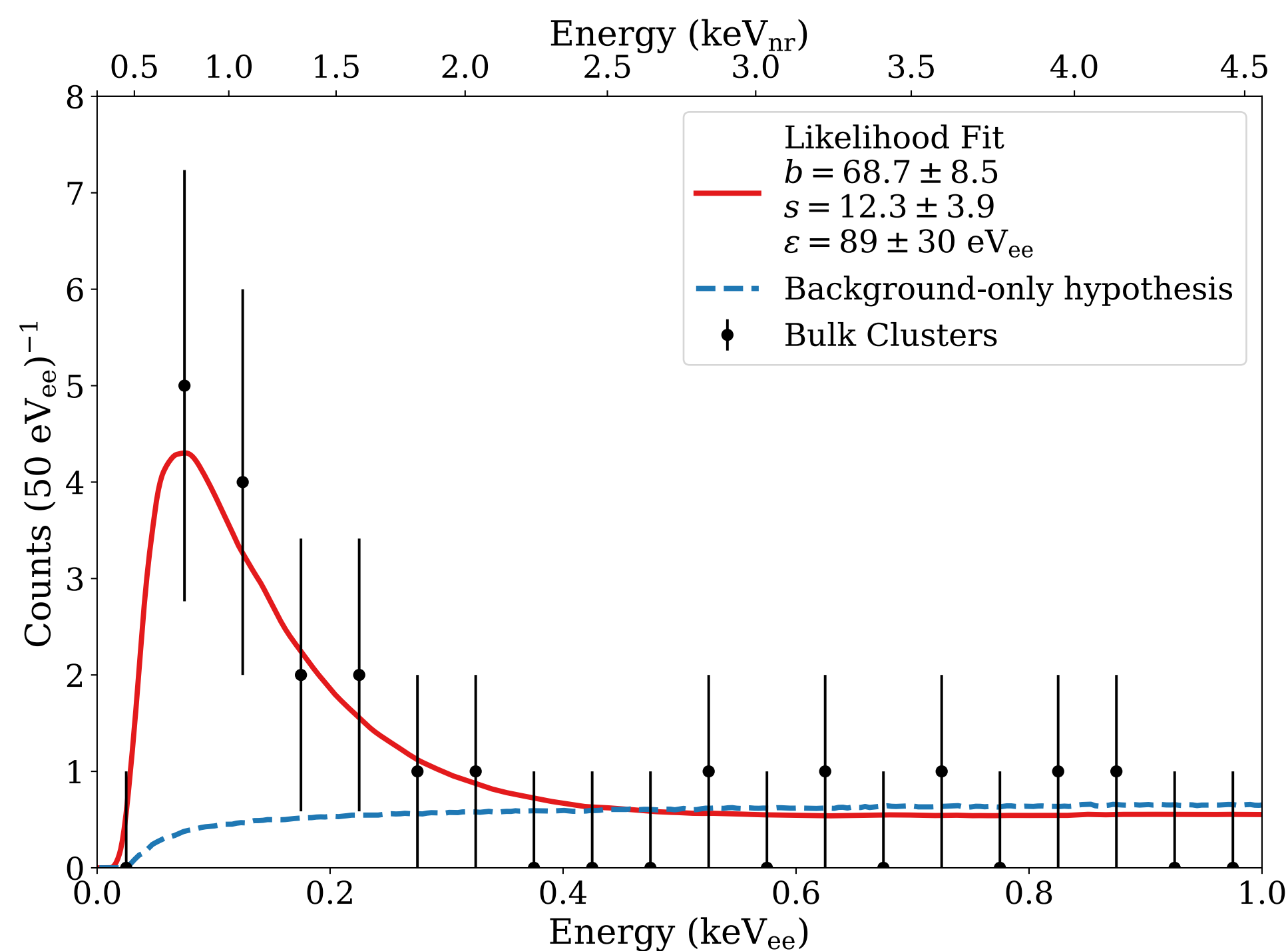
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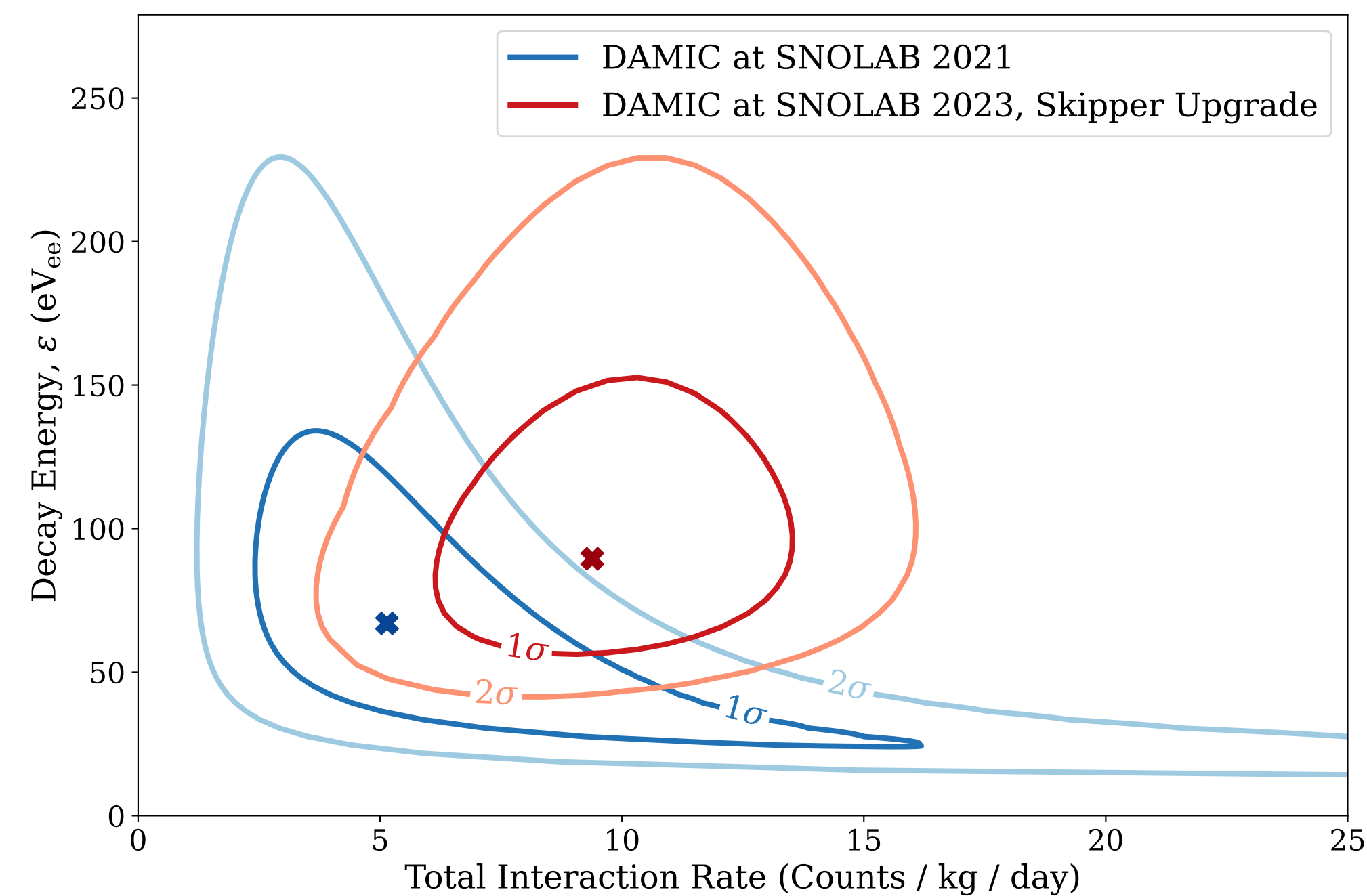
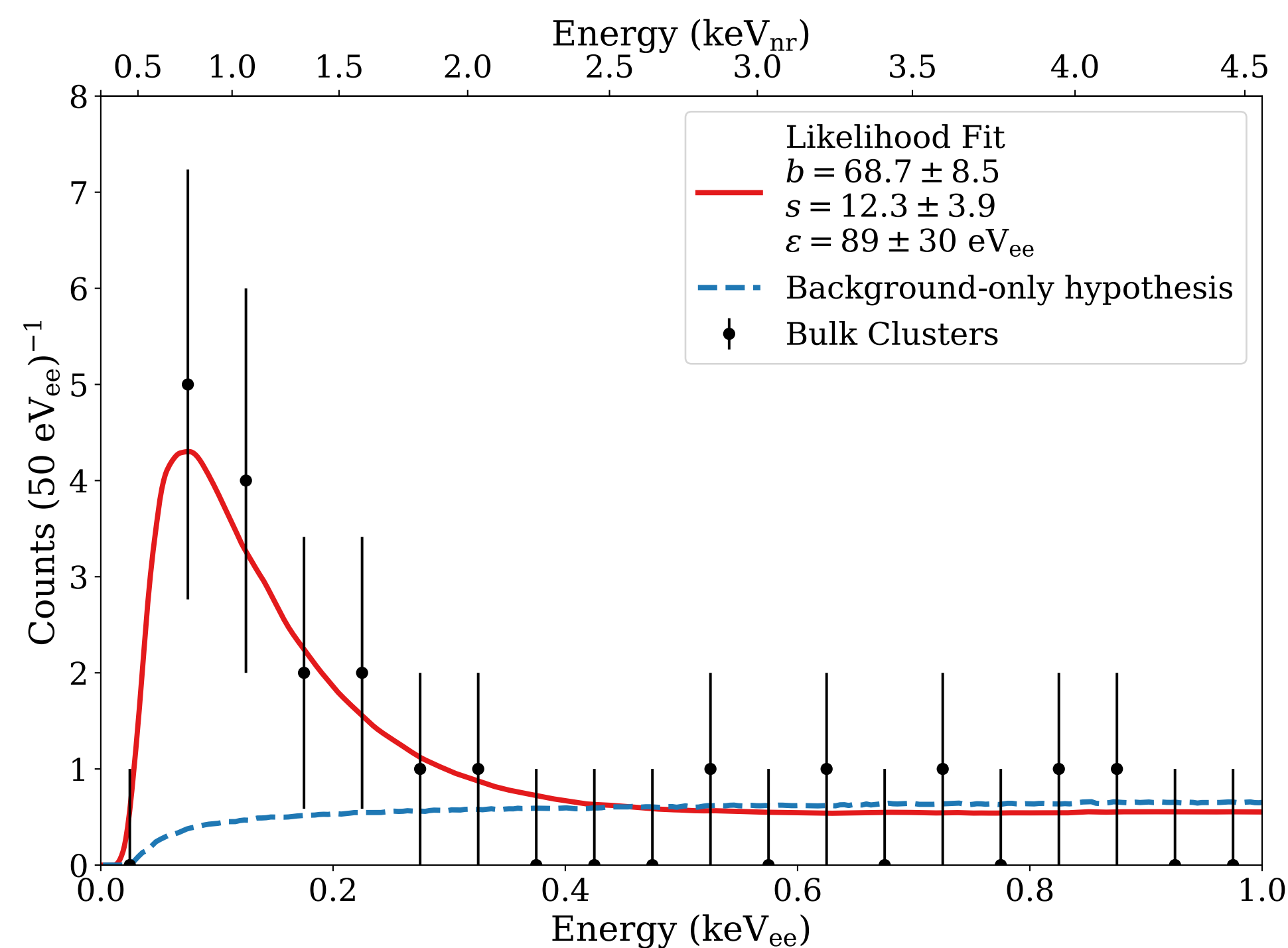
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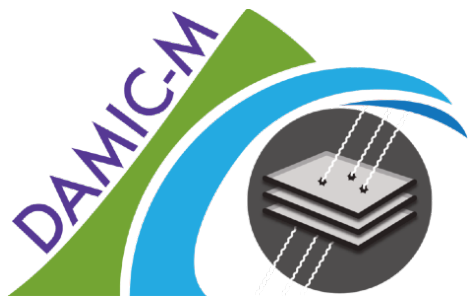
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- The finding is in tension with experimental results from CDMSlite and DarkSide-50

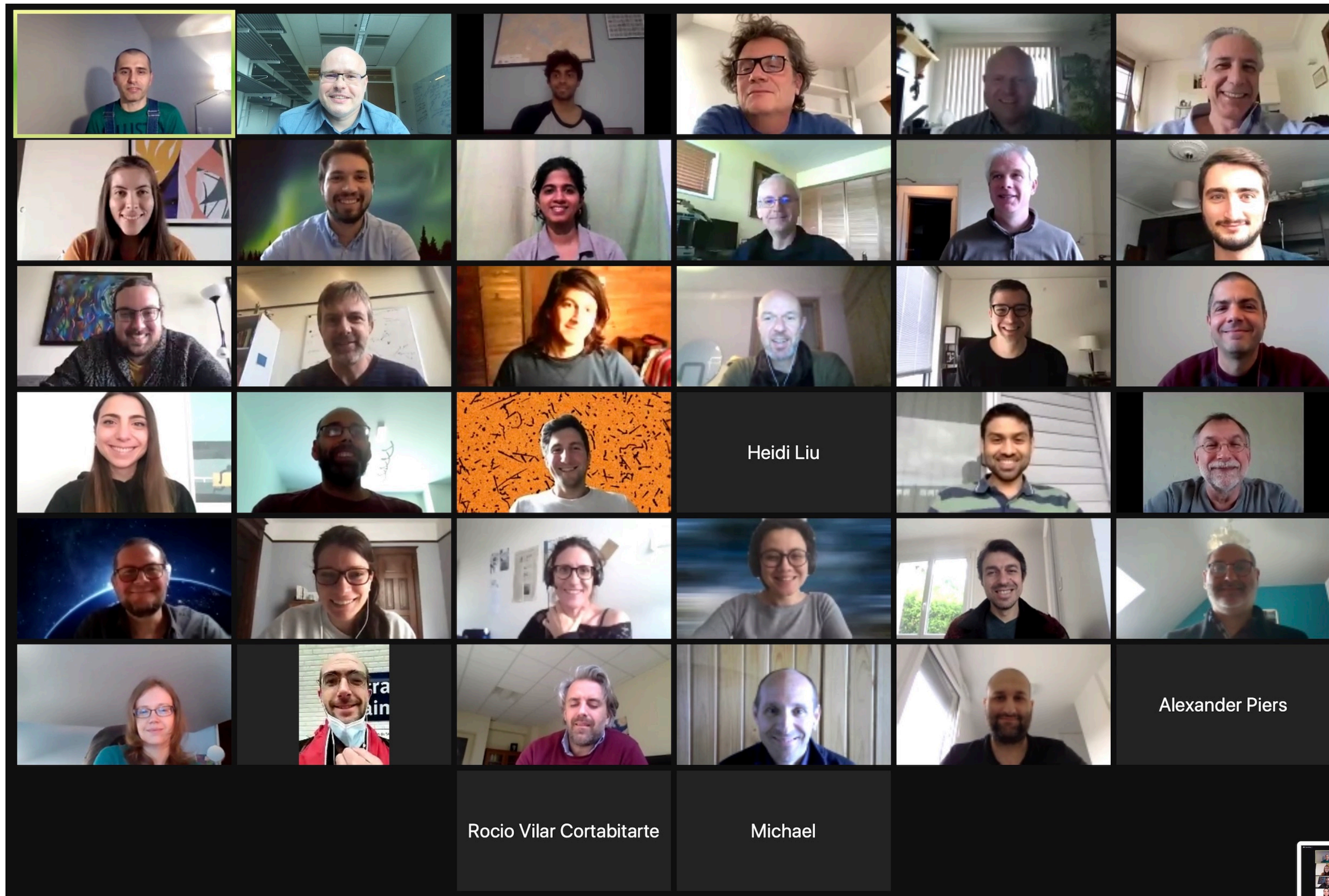
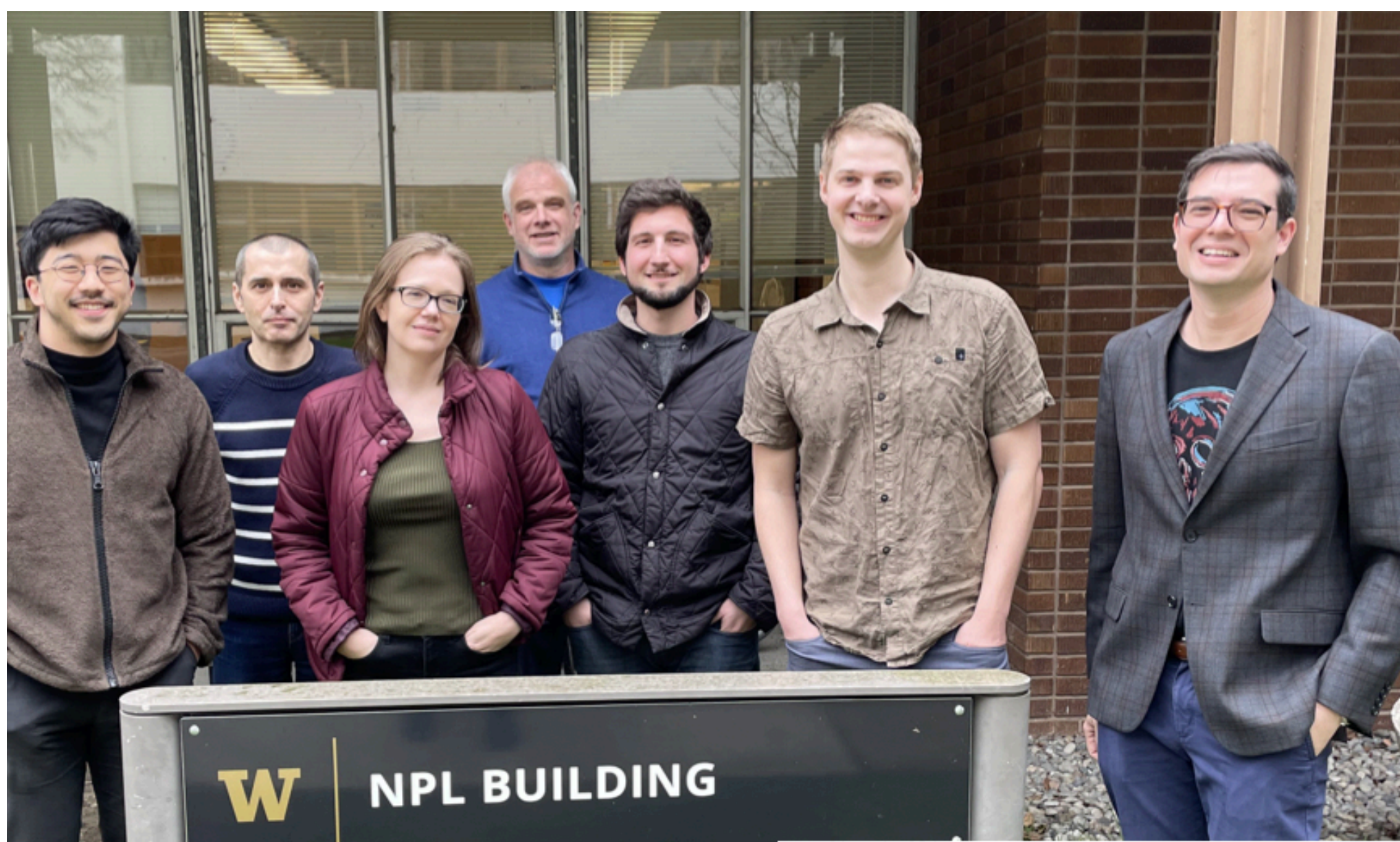
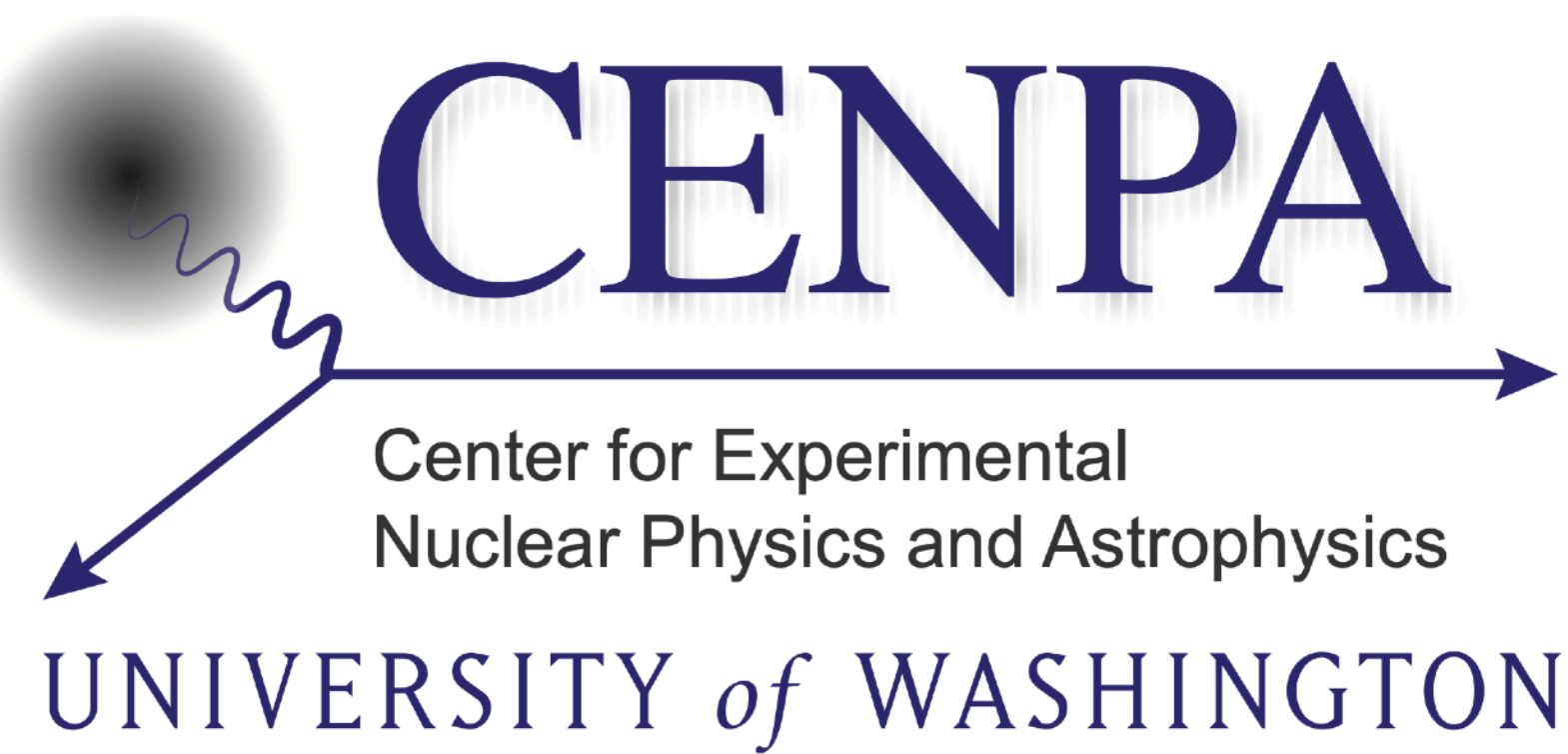
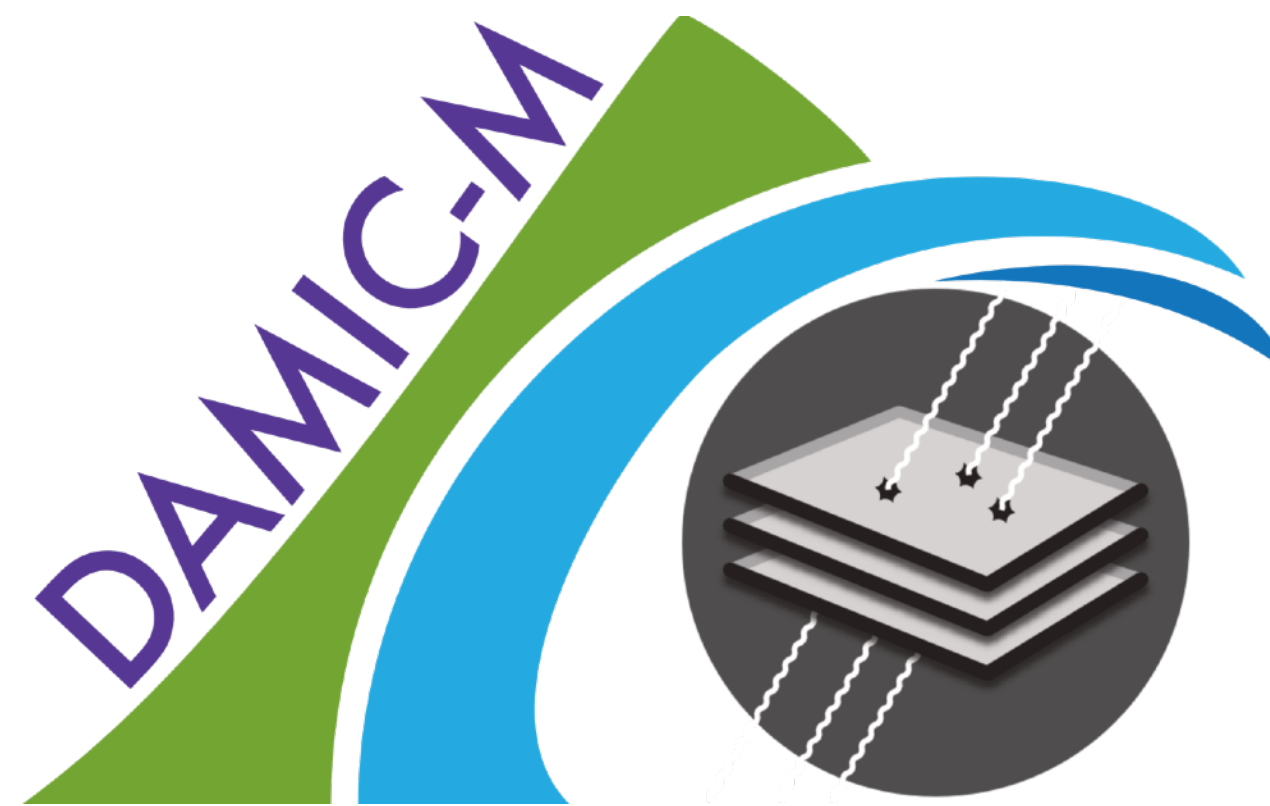
$$m_\chi \sim 2.5 \text{ GeV}/c^2, \quad \sigma_{\chi n} \sim 3 \times 10^{-40} \text{ cm}^2$$





CONCLUSIONS

- DAMIC at SNOLAB pioneered CCDs as Dark Matter detectors:
 - Constructed first comprehensive CCD background model
 - Detected low-energy excess below 500 eV_{ee}
- DAMIC-M will be deployed in 2024
 - ~ 200 skipper CCDs: $\mathcal{O}(\text{kg})$ detector
 - Low-energy excess confirmed with DAMIC-M skippers at SNOLAB [arXiv:2306.01717](https://arxiv.org/abs/2306.01717)
 - Lower threshold with sub-electron noise
 - Rejected most prominent systematic: surface events
 - Unchanged background environment
 - Will investigate excess in DAMIC-M (different) ultra-low background environment and much higher statistics... Stay tuned! [See C. De Dominicis presentation](#)



The DAMIC-M Collaboration

